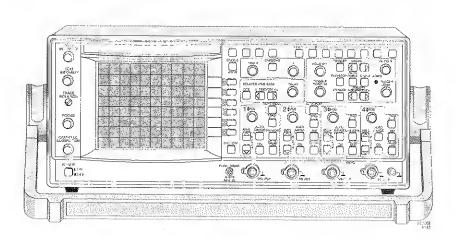
Digital Storage/Analog Oscilloscopes PM3382A-PM3384A 100 MHz 200 MS/s PM3392A-PM3394A 200 MHz 200 MS/s CombiScope™ Instrument

Reference Manual

4822 872 00583 940103



FLUKE.

IMPORTANT

In correspondence concerning this instrument please give the model number and serial number as located on the type plate on the rear of the instrument.

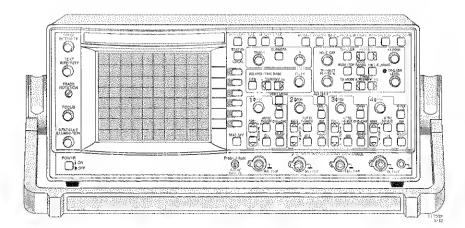
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NOTE: The design of this instrument is subject to continuous development and improvement. Consequently, this instrument may incorporate minor changes in detail from the information provided in this manual.

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or in any form without written permission of the copyright owner.	()
Printed in The Netherlands	Logard
	()



Thank you for purchasing this FLUKE oscilloscope. It has been designed and manufactured to the highest quality standards to give you many years of trouble free and accurate measurements

The powerful measuring functions listed below have been combined with an easy and logical operation to let you use the full power of this instrument each and every day.

If you have any comments on how this product could be improved, please contact your local FLUKE organization. FLUKE addresses are listed in the back of this REFERENCE MANUAL.

There is an OPERATION GUIDE available containing:

- OPERATOR'S SAFETY
- INSTALLATION INSTRUCTIONS
- OPERATING INSTRUCTIONS
- HOW TO USE THE INSTRUMENT
- FUNCTION REFERENCE

|||

PM3382A/PM3384A/PM3392A/PM3394A

There are four models in this family of Fluke oscilloscopes. Each of these models is a combination of an analog real-time oscilloscope and a fully featured digital storage oscilloscope. By pressing a single push button, you can switch the instrument from the analog mode to the digital mode and back. This allows each of the units to be used in an optimum operating mode for all kinds of signal conditions. Complex data streams, modulated waveforms, and video signals can often best be seen in the analog mode of operation. The digital mode of operation is more suited for single events, signals with low repetition frequencies, and when automatic measurements need to be performed.

In this family there is a choice of four models. Two models have a bandwidth of 200 MHz; the two others have a bandwidth of 100 MHz. There is a choice of two models with four fully featured channels or four channels in a '2+2' configuration as shown in the following table:

	PM3382A	PM3384A	PM3392A	PM3394A
Bandwidth	100 MHz	100 MHz	200 MHz	200 MHz
Sample rate	200 Ms/s	200 Ms/s	200 Ms/s	200 Ms/s
Number of Channels	4 (2+2)	4	4 (2+2)	4
Input impedance	1 MΩ	1 MΩ	1 ΜΩ/50Ω	1 ΜΩ/50Ω

In the same instrument family, there are two 200-MHz analog oscilloscopes that have specifications similar to the above-mentioned analog/digital combination oscilloscopes operating in analog mode.

All analog/digital combination oscilloscopes listed above have the following features:

- 8K sample acquisition memory, expandable to 32K.
- Up to 40 waveforms stored in memory or 204 waveforms with optional memory extension.
- Autoset function for an instant optimized signal display at the touch of a button.
- Auto-ranging attenuators.
- Auto-ranging timebase.
- Real time clock.
- Cursor measurements with 1% accuracies.
- Extensive set of fully automated voltmeter and time measurement functions.
- Probe operated 'Touch Hold and Measure' function freezes the display and instantly displays the signal frequency, amplitude and dc voltage level.
- Peak detection for the capture of glitches as narrow as 5 ns.
- Pattern, State and Glitch triggering (2 ns)

IV

- Event delay and pretriggering and posttriggering.
- TV triggering including HDTV and TV line selection.
- Serial interface for printing and plotting.
- Averaging to reduce signal noise and to increase the vertical resolution from 8 to 16 bits.
- Advanced mathematics, including digital low-pass filtering. A Math+ option adds Integration, differentiation, histogramming, and (as part of a option) FFT.
- Sine interpolation and magnification which enables true to life four channel single shot acquisitions with a timebase up to 625 ns/div (32x magnified)
- A delayed timebase with full trigger features.
- An EIA-232-D interface (standard) and an GPIB/IEEE-488 interface (optional).
- Autocal for automatic fine tuning of all circuitry to achieve maximum accuracy under all user conditions.
- Closed case calibration for efficient maintenance of traceable calibration at minimum cost.

The following options are available:

- A MATH+ option with more automated measurement functions including envelope and measurement pass/fail testing. Also included in this option are Integration, Differentiation, Histogramming, and FFT.
- Memory extension offering 32K acquisition length and the ability to store 204 traces (of 512 samples each) in memory.
- IEEE-488.2 interface using the new SCPI (Standard Commands for Programmable Instruments) industry standard for remote control of test and measurement equipment.

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A. Performance Characteristics

- Properties expressed in numerical values with tolerances, ranges, or limits stated, are guaranteed by the manufacturer.
- Properties expressed in numerical values without tolerances, ranges, or limits stated, represent the characteristics of an average instrument.
- This specification is valid if the temperature has not changed more than + or -5 °C since the last AUTO CAL, the probe is of the same type as delivered with the instrument, and if the average factor is 8.
- For definitions of terms, reference is made to IEC Publication 351-1, 359.

B. Safety Characteristics

This instrument has been designed and tested in accordance with IEC Publication 348, Safety Requirements for Electronic Measuring Apparatus, and has been supplied in a safe condition. This manual contains information and warnings which must be followed by the user to ensure safe operation and to keep the instrument in safe condition. The instrument has been designed for indoor use. It may occasionally be subjected to temperatures between +5 °C and 10 °C without degradation of its safety.

C. General Characteristics

Overall dimensions	mensions:	sions	dimens	erall	Ov
--------------------	-----------	-------	--------	-------	----

- Height (without feet)
- Width (without handle)
- Length (without handle and front cover)

: 139 mm (5.5 in) : 341 mm (13.5 in) : 481 mm (19 in)

		. *
1 - 2	1 CHARACTERISTICS	
481 mm		
ATTENTY DECEMBER OF]
		<u>(</u>
		{]
	341 mm 57784 5372	
Figure 1.1 Dimensions		
Weight	9.5 kg (19.7 lb)	
Operating positions: a) Horizontally on bottom fee	et	
b) Vertically on rear feetc) On the carrying handle in	three sloping positions	
	pecifically to only one mode (analog or digital) are	
identified in the leftn	nost column with an 'A' or a 'D'.	
		· · · · · · ·
		1) (1)
		l
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1.1 VERTICAL

1.1.1 Channels

CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION		
CHANNELS	CH1; CH2; CH3; CH4	Form a channel set Form a channel set		
1.1.2 Deflection Modes	(Analog Only)			
MODES	CH1, CH2, CH3, CH4	CH2 and CH4 can be inverted to allow		
	CH1 + CH2	-CH2 or -CH4 CH2 can be inverted to allow CH1 - CH2		
	CH3 + CH4	CH4 can be inverted to allow CH3 - CH4		
Automode:				
Auto attenuator	CH1, CH2, CH3, CH4	PM3382A, PM3392A CH1 and CH2 only		
Windows ON	CH1, CH2, CH3, CH4	PM3382A, PM3392A CH1 and CH2 only See Note 1.		
	Alternate Chopped			
Chopped mode: Chopped freq.	1 MHz			
Note 1: If more than one channel ON.				
1.1.3 Bandwidth				

 FREQUENCY RESPONSE

 Lower transition

 point of BW input

 coupling in AC pos
 <10 Hz</td>

At BNC

BW = bandwidth

			}
- 4		1 CHARACTERISTICS	
	SPECIEICATION		
HARACTERISTICS	SPECIFICATION		
M3392A and PM3394A Ipper transition			
oint of BW	- 000 MU-	BW = bandwidth	()
Ambient 5 to 40 °C) Ambient 0 to 50 °C)	>200 MHz >175 MHz	See Note 1 See Note 1	
M3382A and PM3384A			
pper transition oint of BW		BW = bandwidth	·····
Amblent 5 to 40 °C) Amblent 0 to 50 °C)	>100 MHz 90 MHz	With external 50 Ω With externl 50 Ω	·
ANDWIDTH LIMITER			
pper transition oint of BW	20 MHz	BW = bandwidth	
	rough CH4 in 50 Ω position	at BNC. PM3392A CH1 and	
CH2 in 50 Ω posit	ion at BNC and CH3 and	CH4 at probe tip.	
.1.4 Attenuator			
H1 and CH2			
PM3382A/PM3392A) teps	2 mV/div to 5V/div	In a 1-2-5 sequence	
H3 and CH4	o v / div		
PM3382A/PM3392A)	0.1V/div 0.5V/div		
teps CH1 to CH4	0.59/010		
PM3394A/PM3394A)	2 mV/div to		[···]
teps	5V/div 2 mV/div to	In a 1-2-5 sequence Continuously	
'ariable gain mode	12.5V/div	variable	{}
uto Attenuator	2 <div<6.4< td=""><td>1-2-5 steps precision (min. 50 mV/div)</td><td>[]</td></div<6.4<>	1-2-5 steps precision (min. 50 mV/div)	[]
uto Attenuator	1 <div<3.2< td=""><td>1-2-5 steps precision</td><td></td></div<3.2<>	1-2-5 steps precision	
Windows ON)		(min. 50 mV/div)	
			3
'			()

CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION
1.1.5 Input Characteristi	cs	
INPUT CONNECTOR	BNC	See Note 1
INPUT IMPEDANCE (in 1 MΩ pos.) R parallel-value - tolerance C parallel-value - tolerance	1 MΩ ±1 % 25 pF ±2 pF	Measured at freq. <1MHz
INPUT INPEDANCE (in 50 Ω pos.)		PM3392A only CH1 and CH2 PM3394A all channels
R parallel value - tolerance VSWR (typical)	50Ω ±1 % 1.5:1	See Note 2

Note 1: BNC with Probe Readout pin which causes the instrument to change V/div indication, input impedance, and attenuator setting according to the probe (when equiped with a probe indicator).

1.1.6 Coupling

	COUPLING	dc, ac, ground	See Note 1
--	----------	----------------	------------

Note 1: In GND position: channel disconnected from input, and connected to ground, BNC open (when not in 50Ω position). The GND coupling is not available for channel CH3 and CH4 in PM3382A and PM 3392A.

Note 2: Measured up to 200 MHz input frequency; in dc and ac coupling of input.

1 - 6			1 CHARACTERISTICS	f∳
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CHAR	ACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	
1.1.7	Dynamic Range			
DYNAM Up to 2		i -		
•	2A/PM3384A	±12 div	Symmetrical	
PM339	2A/PM3394A 00 MHz	±12 div	Symmetrical	}
PM338	2A/PM3384A 00 MHz	±4 div	Symmetrical	
	2A/PM3394A	±4 div	Symmetrical	
1.1.8	Position Range			
POSITI	ON RANGE	±8 dìv	Symmetrical	
1.1.9	Trace Separation			
TRACE	SEPARATION		MTB and DTB	
Min. ra	nge	+ or - \ge 4 div	MTB fixed, DTB shifts	i :
1.1.10	Input Voltage Limi	ts		
INPUT	VOLTAGE LIMITS		See Note 1	
\wedge	In high Z position (dc + ac peak)	$\pm 400V$	See Note 2	l
<u>/!</u> \	dc			
In 50Ω ac rms	position	± 5∨ 5∨	See Note 3	
ac peal	<	± 50V	See Note 3	hunt d
Note 1:	The instrument sho	uld be properly grounded th	hrough the protective	
	ground conductor o			
	Up to 10 KHz; >10 I	-		
Note 3:	Maximum of 50 mJ	during any 100 ms interval		
				1 · · · · · · · · · · · · · · · · · · ·

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CHARACTERISTICS SPECIFICATION

ADDITIONAL INFORMATION

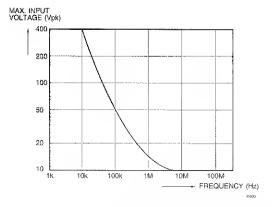


Figure 1.1 Max. input voltage versus frequency

1.1.11 Step Response

5 Divisions Pulse In 50Ω Input Impedance

STEP RESPONSE See Note 1

Note 1: Calculated from the formula: Rise time = 0.35 / Bandwidth and is measured over the central 5 divisions (vertical)

1.1.12 Signal Delay

A: VISUAL SIGNAL DELAY 15 ns

DELAY BETWEEN

<250 ps
<250 ps
<250 ps
<500 ps

4 channel instruments 2+2 channel instruments

1 - 8	L 10.000 (LLL) - 41 (L	1 CHARACTERISTICS	
CHARACTERISTICS	SPECIFICATION		
1.1.13 Vertical Accuracies	\$		
ACCURACY deflection factor			
A: Gain error (dc)	±1.3 %	Over central 6 divisions See Note 1	······································
D: Additional gain error (dc)	±0.7%		
A: Nonlinearity	≤2 %	See Note 2	
D: Digital non linearity	≤3 %		[]
MAX. BASELINE			
INSTABILITY Jump (all between steps, var, and N/I)	0.2 div or 1 mV	Whichever is greater (after autocal)	1 - 1 - 1
Drift Temperature	0.1 div/h	(alter autocal)	
coefficient	0.03 div/K		
CHANNEL ISOLATION Of deselected			
channels at 10 MHz Of deselected	100:1	See Note 3	
channels at upper transition point Between selected	50:1	See Note 4	1]
channels	50:1	See Note 5	
Note 1: Add 1.5% for variab	ole gain mode,		
Note 2: 2 division center sci central 6 divisions.	reen s ignal with a freque	ency of 50 kHz, shifted within	
Note 3: At 10 MHz; input to	deselected channel eq	uivalent to 8 divisions or less.	
Note 4: PM3392A/3394A at to 8 divisions or les	 PM3392A/3394A at 200 MHz; input to deselected chennels equivalent to 8 divisions or less (center screen). 		
Note 5: PM3392A/3394A et with equel V/divisio	t 200 MHz; PM3382A/3 n settings; input to eith		
			·····

1 CHARACTERISTICS		1 - 9		
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION		
1.2 TIMEBASE				
1.2.1 Timebase (modes)				
TIMEBASE MODES	MTB only MTB and DTB DTB only	MTB= Main Timebase Alternating TB-mode DTB = Delayed Timebase		
	Variable TB Auto TB	Пперазе		
MTB trigger modes	AUTO TRIGGERED SINGLE SHOT SINGLE SCAN	Free run after 100 ms		
DTB trigger modes	DTB starts DTB triggered	Starts after delay time Starts on first trigger after delay time		
1.2.2 Timebase Settings (Analog Mode Only)				
MTB PM3392A/PM3394A Settings	0.5s/div to 20 ns/div	See Note 1		
PM3382A/PM3384A Settings	0.5s/dív to 50 ns/div	See Note 1		
PM3392A/PM3394A Variable Time/Div range	1.25s/div to 20 ns/div	MTB continuously variable		
PM3382A/PM3384A Variable Time/Div range	1.25s/div to 50 ns/div	MTB continously variable		
DTB PM3392A/PM3394A Settings	0.5 ms/div to 20 ns/div	See Note 1 See Note 3		

	y ·) A
1 - 10		1 CHARACTERISTICS	
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	
PM3382A/PM3384A Settings	0.5 ms/div to 50 ns/div	See Note 1 See Note 3	
TIMEBASE MAGNIFICATION	10x	See Note 2	
Note 1: In a 1-2-5 sequence is extended to 2 ns.	o. By means of the timebas /div (PM3392A/94A) or 5n		
Note 2: Expands the norma	al time/div by 10 times (M1	FB and DTB)	
Note 3: The DTB sweep sp	eed is higher or equal to I	MTB tíme/dív setting.	()
1.2.3 DTB Delay (Analo	g Mode Only)		
DELAY TIME	2 ns to 4.9s		
Position range	0.1 div to 9.9 div		
Resolution	1: 40000		
1.2.4 Timebese Setting	s (Digital Mode Only)		
MTB Settings REAL TIME SAMPLING ROLL	200s/div to 250 ns/div 200s/div to	See Note 1 and 4	
NOLL	200s/div 200 ms/div	See Note 2	()
RANDOM SAMPLING PM3392A/94A	200 ns/div to 2 ns/div 200 ns/div to	See Note 2]]
PM3382A/84A	200 ns/dlv to 5 ns/div	See Note 2)
Varieble Timebase	100p sec1 μsec 1 μsec 100 μsec	1-2-5 sequence. 1 μsec step size.	
Auto Timebase	100 µsec 200 sec	Equel to analog step size.	
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CHARACTERISTICS	SPECIFICATION	ADDITIONAL	
	· · · · · · · · · · · · · · · · · · ·	INFORMATION	
DTB Settings STARTS/TRIGGERED		See Note 5	
REAL TIME SAMPLING	0.5 ms/dív to 250 ns/dív 0.5 ms/dív to 0.001x	Whichever is greater	
	MTB setting	See Note 1 and 3	
RANDOM SAMPLING only for MTB 200 µs/div to 2 r	ns/div		
PM3392A/94A	200 ns/div to		
	20 ns/div 200 ns/div to	Whichever is greater	
	0.001x MTB setting	See Note 2 and 3	
PM3382A/84A	20 0 ns/div to		
	50 ns/div 200 ns/div to	Whichever is greater	
	0.001x MTB setting	See Note 2 and 3	
Note 1: In a 1-2-5 sequence	250 ns.		
Note 2: In a 1-2-5 sequence			
Note 3: The DTB sweep speed is higher or equal to MTB time/div. setting.			
Note 4: In DTB: 500 ms/div to 250 ns/div.			
Note 5: DTB is only possible	with normal acquisition le	angth.	
Note 6: Triggered DTB is not trigger mode.	possible in combination w	ith tv, logic or event delay	
1.2.5 Timebase Delay (D	igital Mode Only)		
TIME DELAY TRIGGER POSITION Acquisition length			
normal	-10 to 0 div	pretrigger	
Acquisition length max.	-160 to 0 div	pretrigger	

	e le se		7
1 - 12		1 CHARACTERISTICS	1
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	
DELAY Resolution	0 to 1000 div steps of 0.02 div	posttrigger sample distance	,
EVENTS DELAY			
Range	1 to 16384	See event counter	
1.2.6 DTB Delay (Digital	Mode Only)		
TRIGGERED DELAY TIME	2 ns to 4.9 s		()
Position range Resolution	0.1 div to 9.9 div 1 : 40000		
STARTS			
DELAY TIME Position range	0 to 10 div of MTB setting 0 div to 10 div		and the second sec
Resolution	1 : 40000		
1.2.7 Analog Timebase A	Accuracies		
Unmagnified:	± (1.3% of reading +0.5% of central 8 div)	See Note 1	
Magnified: Up to 10 ns div	\pm (1.3% of reading	See Note 2 See Note 1	
In 5ns/div and 2ns/div	+1.0% of central 8 div) \pm (1.8% of reading		
	+1.5% of central 8 div)	See Note 1	
Note 1: Add 1% of reading i			[]
Note 2: Valid over central ur	nmagnified 8 divisions.		[]
1.2.8 Delaytime Accurac	y (Analog Mode)		
MTB in 20 μs/div DTB in 2 μs/div	\pm (0.8% of reading +0.3% of central	A N C	l)
ا اه تعورونا ا	8 div + 4 ns)	See Note 1	I]
Note 1: add 1% of reading in	variable mode.		[]

CHARACTERISTICS SPECIFICATION

ADDITIONAL

1.2.9 DTB Jitter In Starts (Analog Mode)

Jitter 1 part of 25000

1.2.10 Timebase Accuraries (Digital Mode)

MTB, DTB

Real time modes DTB in 2 μs/div up to memory	± (0.8% of reading + 0.5% of central 8 div) ± 0.010%
Equivalent mode	\pm (1.3% of reading + 0.5% of central 8 div)
up to memory	± 0.5%

1.2.11 DTB Jitter In Starts (Digital Mode)

Jitter 120 ps

1.2.12 External Horizontal Deflection

This paragraph is valid only for the analog mode. In the digital mode X versus Y is defined as a display mode.

DEFLECTION SOURCES Line and CH1 to CH4

LINE DEFLECTION Deflection amplitude	6 ±1.7 div	Between 49 and 61 Hz at 220 volts
CHANNEL DEFLECTION Error limit Linearlty error limit Dynamic range up to 100 kHz up to 2 MHz	±5% ±2% 20 div 10 div	Refer to VERTICAL Over central 6 divisions See Note 1
POSITION RANGE	±5 div	

1 - 14				
[• [4		1 CHARACTERISTICS		
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION		
FREQUENCY RESPONSE Upper transition point	2 MHz			
MAX. PHASE DIFFERENCE Between				
horizontal and vertical	3 °	Up to 100 kHz		
Note 1: 2 div/50kHz center	screen signal shifted with	in central 8 divisions.		
1.3 TRIGGERING				
1.3.1 Source				
SOURCE (S) MTB triggering	CH1 to CH4 Line			
SOURCE(S) DTB triggering	CH1 to CH4		3 ().	
1.3.2 Modes				
MODES MTB	EDGE			
triggering	TV D:PATTERN	Enter/exit pattern plus		
	D:STATE D:GLITCH	timed pattern		
MODES DTB triggering	EDGE			
1.3.3 TV Systems				
TV systems	TV HDTV	See Note 1 See Note 1		
Note 1: Line selection possi	ble in field1and field2.			

CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION
1.3.4 Coupling		
BANDWIDTH EDGE TRIGGER MTB		Vertical coupling in DC
Lower transition point of BW		BW = Bandwidth
Trigger coupling: DC AC LF-reject HF-reject	dc 10 Hz 30 kHz dc	
Upper transition point of BW		BW = Bandwidth
Trigger coupling: DC AC LF-reject HF-reject))See sensitivity) 30 kHz	
BANDWIDTH EDGE TRIGGER DTB		Vertical coupling in DC
Lower transition point of BW		BW = bandwidth
Trigger coupling: DC AC LF-reject HF-reject	dc 10 Hz 30 kHz dc	
Upper transition point of BW		BW = bandwidth
Trigger coupling: DC AC LF-reject HF-reject))See sensitivity) 30 kHz	

1 - 16	······	1 CHARACTERISTICS		
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION		
1.3.5 Sensitivity				
EDGE TRIGGER SENSITIVITY		See Notes 1, 3, 4		
MTB and DTB of PM3392A/PM3394A			220 - 220 -	
dc to 100 MHz dc to 200 MHz	0.6 dív 1.2 dív			
dc to 300 MHz	2.0 div	See Note 2		
EDGE TRIGGER SENSITIVITY MTB and DTB of		See Notes 1, 3, 4		
PM3382A/PM3384A dc to 50 MHz	0.6 dìv			
dc to 100 MHz dc to 200 MHz	1.2 div 2.0 div	See Note 2		
TV TRIGGER				
SENSITIVITY (ampl. of sync. pulse)	0.7 div	See Note 1		
TRIGGER SENSITIVITY D: PATTERN/STATE				
PM3392A/PM3394A Rectangle pulses			700,000 e anime 	
$t \ge 10 \text{ ns}$ $t \ge 2 \text{ ns}$	1.0 dìv 2.0 dìv	See Note 5	[]	
PM3382A/PM3384A Rectangle pulses				
$t \ge 20 \text{ ns}$ $t \ge 4 \text{ ns}$	1.0 div 2.0 div	See Note 5		
Note 1: All figures are va 20% for ambient	lid for an ambient tempera 0 to 50 °C.	ature range of 5 to 40 °C, add		
Note 2: Measured with a		signal.		
Note 3: In noise trigger n	nultiply stated value by 2.			
Note 4: In 2 5 mV/div	multiply stated value by 2.		1	
Note 5: Duty cycle 50%.				

CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION
1.3.6 Slope		
Slope selection edge	+ or -	MTB and DTB See Note 1
D:Dual slope	Up to full vertical bandwith	See note 2
Note 1: In TV-triggering pos Note 2: Only in single shot,		
1.3.7 Level		
LEVEL CONTROL RANGE MTB EDGE Unless: In level	±8 div	
p(eak)p(eak) TV	Fixed	See Note 1
D: PATTERN, STATE and GLITCH	±5 div	
LEVEL CONTROL RANGE DTB EDGE	±8 div	
Note 1: The control range c and duty cycle of th		to the peak-peak value
1.3.8 Logic Triggering T	iming (Digital Mode Only)
PATTERN/GLITCH		
DETECTION Max. pattern rate Min. present time	150 MHz	
PM3394A/92A PM3384A/82A	2 ns 4 ns	Pulse amplitude >2 div Pulse amplitude >2 div
range t ₁	20 ns, 30 ns, 40 ns, 50 ns to 0.16s	See note 1
range t ₂	20 ns, 40 ns, 50 ns, 60 ns to 0.16s	See note 1
accuracy $t_1 t_2$	±5 ns	

1 - 18		1 CHARACTERISTICS	
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	
STATE DETECTION Max. state rate Min. setup time Min. hold time	150 MHz 2.5 ns 2.5 ns	Pattern to clock Pattern to clock	
Note 1: Timing behavior	around t_1 and t_2 .		
	e: TTTTTTTTTTTTTTTTTT t ₁ +10 ns	TTTI******* t ₂ -10 ns t ₂	
1.3.9 Trigger Accura	cies		
TRIGGER LEVEL Accuracy edge	≤0.2 div	At 1 MHz input signal	
D: Accuracy logic	≤0.4 div	At 1 MHz input signal	
Trigger gap edge	0.4 div	At 1 MHz input signal in noise trigger multiply by 2	
FALSE TRIGGERS	1:100000	See Note 1	
Note 1; These values ar estimates and la		and are based on theoretical	
			· · · · ·
			· · · · · · · · · · · · · · ·

1 CHARACTERISTICS	
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CHARACTERISTICS SPECIFICATION ADDITIONAL **INFORMATION 1.4 EVENT COUNTER** Event delay EDGE 1 to 16384 See Note 1 TV line 1 to n See Notes 1 and 2 Event enable source CH1 to CH4 Line Logic Event clock CH1 to CH4 Event clock mode Edge Event clock slope selection + or -Event clock coupling AC, DC Event clock sensitivity DC to 50 MHz 0.5 div Event clock level 8 div Max. count frequency 50 MHz typical value

Note 1: In digital mode, triggered DTB in combination with Event is not possible

Note 2: n is equal to maximum lines of TV system

1.5 HOLD-OFF

HOLD OFF SETTING		
A: Minimum	2 µs or 3 divisions	
	of MTB setting	Ŵ
A: Maximum	2s or 20 divisions	
	of MTB setting	W
D: Minimum	4 ms	S
D: Maximum	20 divi <i>s</i> ions of	
	MTB setting	

Whichever is greater

Whichever is *s*maller See Note 1

Note 1: For total hold off time, the process time must be included. See also ACQUISITION TIME.

				2	
1 - 20			1 CHARACTERISTICS	Statut 1	
1-20					
СНАРА	CTERISTICS	SPECIFICATION	ADDITIONAL		
OUMDA	OTENOTOO	SE LOI IOATION	INFORMATION	ll	
1.6 F	PROCESSING				
				(*****)	
1.6.1	Preprocessing				
	0.000000				
FUNCT	OCESSING		See Note 1	r	
FUNCT	IONS	Invert	CH2; CH4	ł	
		Add	CH1+CH2; CH3+CH4;	1 ¹¹¹¹¹	
		100	See Note 2		
		Subtract	CH1-CH2; CH3-CH4;		
			See Note 2		
D:		Peak detection		(····)	
D:		Average	See Note 3		
D:		Env <i>e</i> lope			
Note 1:	These functions are	performed before the a	acquisition data is stored in		
	the acquisition regis		,		
Note 2:	Dynamic range in d	igital mode ±5 div.			
Note 3:	Average factor 2 to	4096 in power of 2 seq	uence.		
	,	,			
100	Deviates Duananai	an (Dinital Mada)			
1.6.2	Register Processi	ng (Digital Mode)			
REGIST	TFR				
PROCE					
FUNCT			See Note 1		
		Add	See Note 2	hand by	
		Sub	See Note 2		
		Mul	See Note 2	1)	
		Filter	LF filter with adjustable -3dB point		
			-odb point		
Note 1:	There mey be run t	wo processes simultane	oously. The ecquisition	lJ	
			ers. The result from process	ì	
			ult from process two will be	r	
	stored in memory t	NO.			
Note 2:	The source can be	env trece from env reais	ter except the result register.		
	The result can be s			I	
				[····}	
				L	
				A construction of the second s	
				l	

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CHARACTERISTICS SPECIFICATION

ADDITIONAL INFORMATION

1.7 TRACE MEASUREMENTS (DIGITAL MODE)

TRACE MEASUREMENTS FUNCTIONS		See Note 1
Horizontal	Frequency Period Puls <i>e</i> width Bis <i>e /</i> fall	
Vertical (with or		
without offset)	Mean RMS Maximum Minimum Peak/peak Low High Overshoot Preshoot Duty cycle Delay	

Note 1: These measurements can be performed on traces stored in the acquisition and memory registers.

Screen

Trace

Time Amplitude Both

Absolute

Ratio

1.8 CURSORS

1.8.1 Cursor Control

NUMBER OF CURSORS 4

CURSOR RELATION D:

CURSOR MODES

Amplitude cursor modes

Fr*ee* Follows the trace

Only screen cursor

See Note 1

1 - 22			1 CHARACTERISTICS	
CHARA	CTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	<u></u>]
Time cu	rsor modes	Absolute	·····	
Phase c	ureor	Ratio Absolute	See Note 1 See Note 1	
Modes		Ratio		(·····)
Note 1:		6 to 999% where 100% cor t the moment that the "∆T=		(,) (,)
1.8.2	Cursor Readouts			
CURSO	R READOUTS	dV		[]
		dT V to GND	See Note 1	
		1/dT dQ(O1, O2) T-trig	See Note 1 See Note 2 See Note 3	
READO	UT RESOLUTION	3 digits		
Note 1:		imebase" and "DTB", all wa performed on the DTB trace		
Note 2: Refer to trigger point (Q1, Q2) Refer to start of trace (Trace in memory, Q1 and Q2).				
Note 3:		es (delta) between the curs		
1.8.3	Cursor Accuracies	(Analog Mode)		
Voltage Manual	measurements	±1% of FULL SCALE	Note 1	
	easurements lified timebase	±1% of FULL SCALE	Note 2	
Magnifie up to 10	d timebase ns/dlv	±1.4% of FULL SCALE		
	d timebase in and 2 ns/div	±2.2% of FULL SCALE		
Note 1:	Measured with 1 kH:	z square wave within centra	al 6 div.	
	within central 8 div.			

1 CHARACTERISTICS		1 - 23	
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	
1.8.4 Cursor Accuracie	es (Digital Mode)		
ERROR LIMIT VERTICAL	See vertical accurecy		
ERROR LIMIT HORIZONTAL	See horizontal accurac	у	
1.9 DIGITAL ACQI	JISITION		
1.9.1 Modes			
MODES Select one:	Recurrent Single shot/scan Roll	Stop on trigger continuous	
1.9.2 Sample Rate			
Real time	Max. Sample rate 200Ms/s	250 ns/div to 200s/div See Note 1	
Equivalent time	Random sampling	2 ns/div to 0.2 μs/div	
Note 1: Sampling rate dep	ends on time/division setti	ing.	
1.9.3 Multiplexed Char	inels		
This instrument has 4 chan the channels CH1 and CH2 share the same dual chann	are multiplexed with the c	as 2 + 2. This implies, that shannels CH3 and CH4 to	
Multiplexed channels (CH1 and CH2) or (CH3 and CH4) Any other combination for timebase settings	simultaneously	See Note 1	1
200s/div to 10 µs/div 5 µs/div to 2 ns/div	CHOPPED ALTERNATED	See Note 2	
		А	

1 - 24			1 CHARACTERISTICS		and a final second s	
CHARA	CTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION			
Mex. Ch	op freq.	5 MHz				
		of the four chennels is ecq			ne. Tablessee	
Note 2:	When peak detectio	n is ectiveted the multiplex	ring is in elterneted mode.		Country of the second	
1.9.4	Trace Memory					
memory		ilsition memory size of 8K ible, it is shared by all char				
Record	length normal	s me enects.))		
1 to 4 ch selected		512 samples/channel		[]		
Record 1 to 4 ch 1 of 4 ch		2K samples/channel 8K samples	See Note 1			
Display		501 samples/trace		; 1	11 A A A A A A A A A A A A A A A A A A	
Note 1:		on or envelope is activated livided by 2 because samp		· · ·	a Anton Villanininina a A A A A A A A A A A A A A A A A A A	
1.9.5	Acquisition Time					
the sele	cted p rocessing. The n acquisitions in a for	cquisitions depends from t prefore it is not p ossible to mula, The next table gives	catch the process time	()		
	ance of the processin	ng capabilities.				
acquisit	time between ions 500 ns/dlv		See Note 1 Holdoff i <i>s</i> min and no			
one cha no trigg acquisit		6 m <i>s</i>	proc <i>ess</i> es or me <i>es</i> urements are		Provide a f	
500 n <i>s</i> /	div		active			
two cha no trigg	nnel		Holdoff Is min and no other proc <i>ess</i> es or			
acquisit ave ra ge	ion length = 512) = 8	16 m <i>s</i>	measurements are active			
					3	

	ACTERISTICS		1 - 25
CHARACTERISTICS		SPECIFICATION	ADDITIONAL INFORMATION
	ent time		See Note 2
Timeba: - at 2 ns		2s	
at 0.2		100 ms	
	Time required to	fill the acquisition record a ith the selected timebase s	
Note 2:	being updated to	the new acquisition. Trigg sted in production and are	ability of all sample positions er frequency >2 kHz. These based on theoretical
1.9.6	Resolution		
ACQUI: RESOL		8 bits	over 10.24 divisions
1.9.7	Registers		
NUMBE REGIST Acquisit - Norma - Max:	FERS ion length:	9 sets 3 sets	Including current acquisition One set contains: Four traces Four traces
	-2x4k -1x8k		Two traces One trac <i>e</i>
WORD	LENGTH	16 bits	
1.9.8	Register Manip	ulations	
Clear			The contents of the selected register is set
Save			to zero The contents of the acquisition register is stored in the selected register

1 06		1 CHARACTERISTICS	2011 - La Area Area (1997)	
1 - 26				
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION		
Сору		The contents of a selected register is stored in another		
Recall		selected register The register can be		
		made visible on the display or can be removed from the display		
1.9.9 Digital Acquisition	Accuracies			
SAMPLING RATE ERROR	±0.01%	X-tal		
TIME UNCERTAINTY At double sampling rate	±100ps			
1.10 FRONT PANEL	MEMORY			
Memory size	10 fronts			
			{]	
			II	

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CHARACTERISTICS SPECIFICATION

ADDITIONAL

1.11 BLANKING OR Z-AXIS (ONLY FOR ANALOG TRACE)

Input connector	BNC	
Input impedance	10 kΩ	
Input coupling	dc	
Max input voltage	±10V	
Input voltage unblank	0.5V or less	See Note 1
Input v ol tage blanked	+ 2.4 V or more	See Note 1
Response time	80 ns	Rise time 2 ns

Note 1: Half tones are possible at input voltages between +0.8V and +2.4 V. Blanking has only effect on the trace in analog mode.

1.12 DISPLAY

1.12.1 CRT

CRT Deflection Dimensions (hxw) Phospor Standard	Electrostatic 80 mm x 100 mm Green GH (P31)	Vector 8 x 10 divisions
GRATICULE Y-AXIS	Fixed	
ORTHOGONALITY	90 ° ±0.5 °	
VOLTAGE	16,5 kV	
Writing speed	>1.8cm/ns	
TRACE ROTATION		Screwdriver adjustment
Min. range	10 °	External field <0.1 mT
Min. overrange	2 °	
TRACE DISTORTION		
At center of screen	<0.3 mm	Deviation from straight line inside 6 x 6 div
Else	<1.0 mm	

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1 - 28		1 CHARACTERISTICS	
		T ONANAO TENIO TOS	
			(
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	
1.12.2 Modes			······
1.12.2 WOURS			
PRESENTATION MODES	Y versus T		
	Y versus X		
1.12.3 Vertical Display Ma	anipulations (Digital Moc	le)	
Linear		Linear interpolations	i norma di seconda di s
		between measured	
0		dots	(
Sine		Sine like interpolation between measured	i
		dots	
Vertical magnify	2, 4, 8, 16, 32		
Windows	1, 2, 4	Each trace has his own	
		place on the screen max. 4 traces	
Desellings			
Recall trace		Each trace can be made visible on the	
		screen or can be	
		removed from the	
		screen. Note 1	
Vertical position	± 8 div	Each trace can be	
		moved over 8 divisions	
Max. displayable traces on screen	Ö	See Note 1	
	8	366 MO(6 1	
Note 1: At least one trace is	; visible.		
			· · · · ·
1.12.4 Horizontal Display	Manipulations (Digital N	lode)	
TIMEBASE			
MAGNIFICATION	2, 4, 8, 16, 32	See Note 1	
Note 1: For acquisition dept	h graater then 512 bute it	is possible to make the	
	less than one (compress)		()
complete trace on th			ld

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CHARACTERISTICS SPECIFICATION

additional Information

1.13 EXTERNAL INTERFACES

1.13.1 Calibrator

square wave	
1200Ω	
600 mV 1%	See Note 1
0.5 mA	See Note 2
2kHz ±20%	
	1200Ω 600 mV 1% 0.5 mA 2kHz

Note 1: Positive going with respect to ground; Open voltage (halves when terminated with 1200Ω).

Note 2: When output short circuited (halves when terminated with 1200Ω).

1.13.2 Standard external interface

TYPE QF INTERFACE	RS 23	32-C	CPL (compact programming language) See operating guide
PINNING			
PIN	I/O	NAME	
1	-	*	Not connected
2	I	RXD	Received data
3	0	TXD	Transmitted data
4	0	DTR	Data terminal ready
5	-	GND	Signal ground
6	1	DSR	Data set ready
7	0	RTS	Request to send
8	1	CTS	Clear to send
9	-	**	Not connected

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		1 CHARACTERISTICS
	SPECIFICATION	ADDITIONAL INFORMATION
ANSMISSION MODES	Asynchronous Full duplex	
IDSHAKE Iware	RTS/CTS and DSR/DTR	Default: not active See Note 1
ftware	XON/XOFF	Default: not active See See Note 1
JDRATE	75,110,150,300 600,1200,2000, 2400,4800,9600 19200,38400	Receiving and transmitting Default:1200 See Note 1
MBER OF STOP BITS	1	
ITY	odd,even,or no	Default: no parity See Note 1
ARACTER LENGTH	7 or 8	Default:8 See Note 1
OR RESPONSE	See CPL operating manual	
CTRICAL and RXD sing "0" sing "1"	≥ +3V ≤ -3V	
S,CTS,DSR and DTR	≥ +3V ≤ -3V	
rent output	≤10mA	
edance out t	300Ω ±10% ≥3 kΩ ≤7kΩ	
age put ut	≥ -12V ≤ +12V ≥ -25V ≤ +25V	
nector	Shielded	9 pole RAP mal <i>e</i> connector according MIL-C-24308

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1 CHAI	RACTERISTICS		1 - 31
CHARA	ACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION
1.13.3	Optional external	interfaces	
IEEE		ANSI/IEEE 488.2	SCPI See section 1.20.5
1.13.4	Printers and plott	ers support	
PRINTI	ERS	HP-thinktjet LQ1500 FX80 HP-LASER	
PLOTT	ERS	HPGL HP7440 HP7550 HP7475A HP7478A PM8277 PM8278	
1.13.5	Real Time Clock		
(RTC) S <i>e</i> le	ect:	Time of trigger or	Note 1
		Tim <i>e</i> of pressing hardcopy button	Note 2
Note1:	These times may b time of trigger,	e the same when it is not p	ossible to reconstruct the
Note2:	- Stamped on any	hardcopy via hardcopybuttc ata transfer waveform.	חמ
1.14	AUTO SET & C	ALIBRATION	
1.14.1	Auto Set		
intensity	SET selects the prop y, and triggering for a nble AUTO SET item	er channel, sets vertical def in easy-to-read display of ir is.	ilection, timebase speed, aput signals, or the user

			1
1 - 32		1 CHARACTERISTICS	
[- \$2	······································		[]
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	[]
1.14.2 Calibration			10 South
CALIBRATION FACILITIES	Auto cal	See Note 1	
		al offset and gain and sweep	
time, trigger offse			
1.15 POWER SUPP	YLY AND BATTER	Y BACKUP	
1.15.1 Power Supply			
LINE VOLTAGE			1 []]
ac (rms) Operation	100V to 240V		
Tolerance	±10%		: 5
LINE FREOUENCY Nominal Limits of operation	50 Hz to 400 Hz 45 Hz to 440 Hz		ц.,
LINE WAVEFORM		At nominal source	
CHARACTERISTICS Max. waveform		voltage	
Deviation factor	10% 1.07 to 1.56		1
Crest factor	1.27 to 1.56		ì/
ALLOWABLE POWER	20 ms	See Note 1	[]
POWER CONSUMPTION			
Without options Max. power	115W		
consumption	130W		
	2.1m (82.7 in)		Ì
Length Power plug	Nat.version		
Note 1: At the lowest allo	wable source voltage. A	fter this time the oscilloscope lown, and an automatic power-	}
on sequence sta	rts after restoration of the	power source voltage.	·····
			}

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CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION
1.15.2 Battery Backup		
DATA AND SETTINGS RETENTION		See Note 1

Retention time Batteries:	2 years	
Recommended type Quantity	LR 6 2	See Note 2
Temperature range	0+70 °C	See Note 3

Note 1: When instrument is switched off or during power failure.

- Note 2: According to IEC 285 (=Alkaline Manganese Penlight Battery).
- Note 3: At -40 to 0 °C, settings retention is uncertain. It is advised to remove batteries from instrument when it is stored during longer periods (>24 hours) below -30 °C or above 60 °C. UNDER NO CIRCUMSTANCES SHOULD BATTERIES BE LEFT IN THE INSTRUMENT AT TEMPERATURES BEYOND THE RATED RANGE OF THE BATTERY SPECIFICATION

1.16 MECHANICAL CHARACTERISTICS

PORTABLE VERSION		
Dimensions:		Handles excluded
Length	481 mm (19 in)	Add 5 mm (0.2 in) for cover Add 65 mm (2.5 in) for handle
Width	341 mm (13,5 in)	Add 50 mm (2 in) for handle
Height	139 mm (5,5 in)	Add 8 mm (0.3 in) for feet
Weight:		
Instrument	9.5 kg (19,7 lb)	
COOLING	Regulated Forced air	No air filter

1 - 34	~~~~~~	1 CHARACTERISTICS	
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	[]
1.17 ENVIRONMEN	TAL CHARACTER	RISTICS	
1.17.1 General))
official checking procedure.	l only if instrument Is che Warm up and recovery t	cked in accordance with the ime are in accordance with	
MIL-T 28800D par. 3.7.1.1.			[]
The instrument meets the e Class 3, Style D, Color R (u		nts of MIL-T-28800D Type III e).	
1.17.2 Environmental			
TEMPERATURE		See Note 1	
Operating: min.low temp. max.high temp.	0 °C +50 °C		÷
Nonoperating (storage): min. low temp. max. high temp.	-40 °C +70 °C		1
MAX. HUMIDITY		See Note 1	,
Operating and Non operating (storage)	95%	Relative humidity noncondensing	
MAX. ALTITUDE Operating	4.6 km (15000 ft)	See Note 2 See Note 3	[]
Nonoperating (storage)	12 km (39000 ft)		
VIBRATION (OPERATING)		See Note 4	
Freq. ranges:	5 Hz to 15 Hz	g level at max. freq.: 0.7 at 15 Hz	
	16 Hz to 25 Hz 26 Hz to 55Hz	1.3 at 25 Hz 3 at 55 Hz	
			[]
]

CHARA	CTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION
Cycling 1 Resonar	freq.range: time nce search nce dwell	15 min 5 min 10 min	See Note 5
Note 1:	In accordance with N	AIL-T-28800D par. 3.7.2.1.	1. (FIGURE 2).
Note 2:	In accordance with N	AIL-T 28800D par. 3.7.3.	
Note 3;	Maximum operating level	temperature derated to 3°C	C for each km above sea
Note 4:	In accordance with N	AIL-T-28800D par. 3.7.4.1.	
Note 5:	At each resonance f	requency (or at 33 Hz if no	resonance was found).
Amount total each axi Shock w Duration	aveform	18 6 half sinewave 6-9 ms 400 m/s ²	See Note 6 3 in each direction
	HANDLING equirements of	MIL-ST-810 method 516 procedure V	See Note 7
TRANS	PORTATION	Drop height 0.76m	See Note 9
SALT AT Structura	MOSPHERE al parts		See Note 8
Note 6:	In accordance with N	//IL-T-28 800 par. 3.7.5.1.	
Note 7:	In accordance with N	И L-T-28800 par. 3.7.5.3.	
Note 8:	In accordance with N	/IL-T-28800 par. 3.7.8.1.	
Note 9:	Drop in shipping cor	tainer on 8 corners, 12 ed	ges, 6 surfaces.

CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION
1.17.3 EMI		
1.17.3.1 Meets MIL-T 28 specified otherw	• •	levy requirement, unless
Meets MIL-STD-461C as for - Conducted Emissions	Part 2 CEO1 Part 4 CEO3	(Narrow band)
- Conducted Susceptibility	Part 2 CSO1 Part 5 CSO6	(Limited to 300V)
- Radiated Emissions	Part 5,6 REO1 Part 2 REO2	(1 GHz max)
1.17.3.2 VDE requireme	nts	
The instrument meets the	requirements of VDE 08	71 Gronzwert-klasse B
		T GIGHZWOIT RIG550 D.
1.17.3.3 Additional EMI		AT CIERZWORK NO.350 D.
1.17.3.3 Additional EMI The instrument is tested in deflection factor is 7 mm/n	requirements accordance with IEC 35 nT (0.7 mm/gauss). This bus field (in any direction to peak value) of 1.42 m	1-1 par. 5.1.3.1. The maximum value measured with the with respect to the instrument) T (14.2 gauss) and of
1.17.3.3 Additional EMI a The instrument is tested in deflection factor is 7 mm/n instrument in a homogeneous with a flux intensity (peak f	requirements accordance with IEC 35 nT (0.7 mm/gauss). This bus field (in any direction to peak value) of 1.42 m	1-1 par. 5.1.3.1. The maximum value measured with the with respect to the instrument) T (14.2 gauss) and of
1.17.3.3 Additional EMI The instrument is tested in deflection factor is 7 mm/n instrument in a homogeneo with a flux intensity (peak is symmetrical sine wave for	requirements accordance with IEC 35 nT (0.7 mm/gauss). This bus field (in any direction to peak value) of 1.42 m	1-1 par. 5.1.3.1. The maximum value measured with the with respect to the instrument) T (14.2 gauss) and of
1.17.3.3 Additional EMI The instrument is tested in deflection factor is 7 mm/n instrument in a homogened with a flux intensity (peak f symmetrical sine wave for 1.18 SAFETY MEETS	requirements accordance with IEC 35 nT (0.7 mm/gauss). This bus field (in any direction to peak value) of 1.42 m m with a frequency of 45 IEC 348 Class I UL 1244 CSA C22.2 No231	1-1 par. 5.1.3.1. The maximum value measured with the with respect to the instrument) T (14.2 gauss) and of 5 Hz to 66 Hz. See Note 1 See Note 2 See Note 2 See Note 2
1.17.3.3 Additional EMI The instrument is tested in deflection factor is 7 mm/n instrument in a homogened with a flux intensity (peak f symmetrical sine wave for 1.18 SAFETY MEETS REQUIREMENTS OF	requirements accordance with IEC 35 of (0.7 mm/gauss). This bus field (in any direction to peak value) of 1.42 m m with a frequency of 45 IEC 348 Class I UL 1244 CSA C22.2 No231 VDE 0411	1-1 par. 5.1.3.1. The maximum value measured with the with respect to the instrument) T (14.2 gauss) and of 5 Hz to 66 Hz. See Note 1 See Note 2 See Note 2 See Note 2

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CHARACTERISTICS SPECIFICATION

ADDITIONAL

1.19 ACCESSORIES

PACKED WITH INSTRUMENT Signal input

2x10 MΩ 10:1 probe Contrast filter Front cover With readout (1.5 m) Blue Can be locked on instr.

Operating guide

Reference manual

1.20 OPTIONS & OPTIONAL VERSIONS

1.20.1 Options Line cord

LINE CORD

Universal European	In accordance with VDE
North American	In accordance with CSA, UL
United Kingdom	In accordance with BSI
Australian	In accordance with SAA
Swiss	In accordance with SAV

1.20.2 Options digital versions

EXTERNAL INTERFACES	IEEE	Factory installed only
INTERNAL EXTENSIONS	EXTENDED	
	MEMORY	Factory installed only
	MATH+	Factory installed only

1.20.3 Options analog versions

EXTERNAL INTERFACES	Y-out, MTB gate,	
	DTB-gate, ExtTrig.	Factory installed only
	IEEE	Factory installed only

1 - 38		1 CHARACTERISTICS	
)
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	
1.20.4 Specification option	nal outputs		
Y SIGNAL OUT	BNC		
Source Coupling	CH1 as CH1		()
Voltage:	asoni		1)
into 1 MΩ	20mV/div		
with a tolerance of	±10%		
into 50Ω	10mV/div		
with a tolerance of	±10%		
Freq. response Installed in	dc to	Terminated with 50Ω	[]
PM3392A/94A	200 MHz		» ı
Installed in			.i
PM3382A/84A	100 MHz		r a
Dynamic range	±10 div	At 50 MHz	
MTB GATE OUT			
Connector	BNC		
Output impedance	1 kΩ		
Voltage:Timebase not running	$0.2 \pm 0.2 V$		
Timebase running	3.7 ± 1.3V		
DTB GATE OUT			1
Connector	BNC		1. ss - 2
Output impedance	1 kΩ		Γ.
Voltage:Timebase			()
not running	$0.2\pm0.2V$		(
Timebase running	3.7 ± 1,3V		
1.20.5 Specification Exter	nal trigger option		
SOURCE			1
SOURCE(S) MTB-triggering	CH1 CH4		[]
	External	no line triggering	
	Composito	(in analog models)	
	Composite	Combi-scopes: line	
			(
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	ERISTICS	······································	1 - 39
CHARACTER	ISTICS	SPECIFICATION	ADDITIONAL INFORMATION
INPUT CHAR	ACTERISTIC	S	- 17
	ECTOR	BNC	At rear of instrument
INPUT IMPE	DANCE		Measured at freg. <1MHz
C parallel - v	lerance	1 ΜΩ ±1% 25 pF ±5 pF	
DYNAMIC RAUP to 10 MHz		±2.5V	Symmetrical
	VOLTAGE LI a.c. peak)		See note 1 See note 2
	araturs should luctor of the p		ough the protective ground
Note 2: Up to	o 10 kHz; >10	kHz see figure 1.1.	
SENSITIVITY			
EDGE TRIGO d.c. to 5 MHz d.c. to 10 MH		VITY 100 mV 200 mV	See note 3
Note 3: In no	bise-trigger mi	ultiply stated value by 2.	
TRIGGER LE	VEL		
TRIGGERLE Range Accuracy	/EL	±1.5V ≤0.4V	See note 4 at 1 kHz input signal triggercoupling DC

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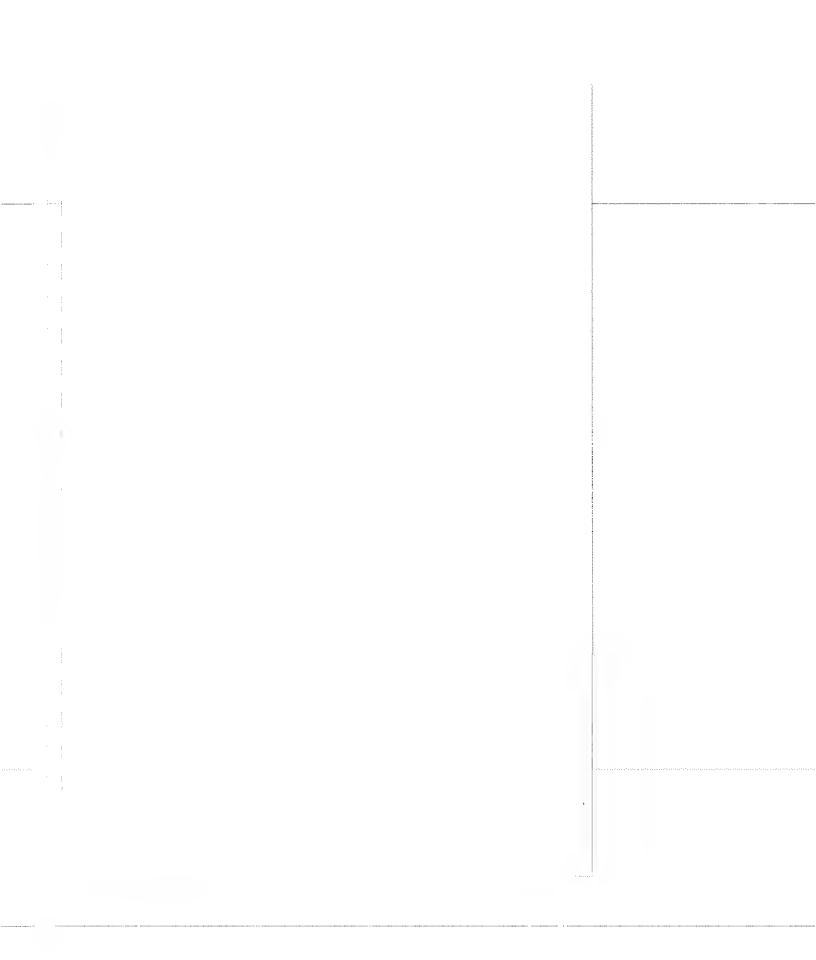
1 - 40		1 CHARACTERISTICS
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION
1.20.6 Specification IEE	E-OPTION	
TYPE OF INTERFACE	ANSI/IEEE 488.2	SCPI (see SCPI programming manual) See Note 1
INTERFACE REPERTORY		
Source handshake Acceptor handshake Talker	SH1 AH1 T5	Complete capability Complete capability Basic talker: yes Serial poll : yes Talk only : yes Unaddress if MLA: yes
Listener	L3	Basic listerner: yes Listener only : yes Unaddress if MTA: yes
Service request Remote local Parallel poll	SR1 RL1 PP0	Complete capability Complete capability No capability
Device clear Device trigger Controller	DC1 DT1 C0	Complete capability Complete capability No capability
ELECTRICAL INTERFAC		
Busdrivers	E2	Three state (true=0 to 0.8V;false=2 to 5V)
Connector	Shielded	Amphenol type 57FE-20240-20SD35
Pin 1 4 Pin 13 16 Pin 18 23 Pin 24 23 Pin 5 16 Pin 6 Pin 7 Pin 8 Pin 10 Pin 10 Pin 12 Pin 17	DIO1DIO4 DIO5DIO8 GND Logic GND EOI DAV NRFD NDAC IFC SRQ ATN Shield REN	

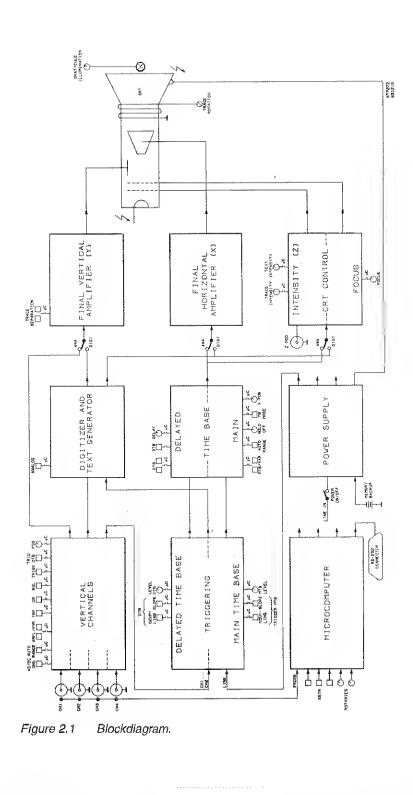
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CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION		
FUNCTION SELECTION	Via UTILITY-MENU	Busaddress Default: 8 See Note 2		
INTERFACE STATUS INDICATOR	On screen			
Note 1: Talker/listener				
Note 2: When battery installe	ed, same as last power-off	value.		
1.20.7 Extended memory				
If extended memory option is digital mode), 1.9.4 (Trace me next three paragraphs.				
(1.2.5) Time base delay (dig	ital mode)			
TIME DELAY TRIGGER POSITION acquisition length normal	-10 to 0 div.	pretrigger		
acquisition length max.	-640 to 0 div	pretrigger		
DELAY Resolution	0 to 1000 div steps of 0.02 div	posttrigger sample distance		
EVENTS DELAY Range	1 to 16384	See event counter		
(1.9.4) Trace memory				
This digitizer has a total acquisition memory size of 32 kbyte. To apply this memory as efficient as possible it is shared by all channels connected to it. The following section summarizes the effects:				
Record length normal 1 to 4 channels selected	512 samples/channel			

1 - 42	والمحمد	1 CHARACTERISTICS	}}
CHARACTERISTICS	SPECIFICATION	ADDITIONAL INFORMATION	
Record length 'Max' 1 to 4 channels selected 1 of 4 channels	8k samples/channel 32k samples	See Note 1	
Display	501 samples/trace)
	tection or envelope is activate be divided 2, because sampl		[]
(1.9.7) Registers			
NUMBER OF REGISTERS one set contains:		Including current acq.	<u> </u>
Acquisition length:		fa	
-Normal -Max: -4 x 8k -2 x 16k	51 sets 3 sets	four traces four traces two traces	
-1 x 64k		one trace	
WORDLENGTH	16 bíts		
			()







2 PRINCIPLE OF OPERATION

2.1 INTRODUCTION

This chapter describes the principle of operation end should be read in combination with the block diagram in figure 2.1.

The block diagram shows the user in which sections of the oscilloscope circuitry the controls and keys are operating, and how signals are routed. For a detailed description of each function, refer to chapter 5 'Function Reference' in the Operating Guide.

Lines between controls/keys and the block they are operating are interrupted. The text ' μ C' at the interruption indicates that the control operates the block via the microComputer.

2.2 CONTROL SECTION

The heart of the control section is formed by a MICROCOMPUTER with an incorporated RS-232 interface. The MICROCOMPUTER reads all the keys (except POWER ON/OFF) and rotary controls. It sends control signals to the oscilloscope circuits to put them in the desired mode. Control of the oscilloscope functions can also be done by an external computer connected to the RS-232 CONNECTOR.

2.3 VERTICAL DEFLECTION

This section consists of the blocks VERTICAL CHANNELS and FINAL. VERTICAL AMPLIFIER, There are four vertical channels. Small differences between the channels depend on instrument versions. The inputs CH1 ... CH4 are applied to the block VERTICAL CHANNELS. In this block the following functions are made:

- Input coupling can be switched between AC, DC and GND. As en extra 50Ω input impedance can be selected in the 200 MHz models via the VERT MENU key.
- The AMPL/VAR key peir determines the input sensitivity of each channel. The most suitable input sensitivity is selected automativally if AUTO RANGE is ective. Some channels may heve a switch to toggle between the two most commonly used input sensitivities.

PRINCIPLE OF OPERATION

- Each channel can be switched on/off with the ON key and bandwidth can be limited to 20 MHz via BW LIMIT 'on' in the VERT MENU.
- Trigger source selection for MTB and DTB is done via the keys TRIG1 ... TRIG4 and the menu under the DTB key.
- The vertical signal position of each channel can be adjusted with a POS control.

The FINAL VERTICAL AMPLIFIER drives the vertical deflection system of the Cathode Ray Tube (CRT). The TRACE SEPARATION key pair adjusts the vertical distance between MTB and DTB display, when in Alternate Timebase Mode.

2.4 HORIZONTAL DEFLECTION

The horizontal deflection consists of the blocks TRIGGERING, TIMEBASE and FINAL VERTICAL AMPLIFIER. TRIGGERING and TIMEBASE are both split up in sections for MTB and DTB; these sections are almost identical.

Triggering can be done via CH1 ... CH4 or a signal derived from the line voltage. The following controls adjust the triggering:

- COUPLING permits selection between ac, dc, lf-reject, hf-reject and noise suppression.
- SLOPE permits triggering on positive- or negative-going signal edges.
- LEVEL adjusts the signal level where the timebase is started.

The output of the TRIGGERING generates a pulse that starts the TIMEBASE.

The TIMEBASE generates a so-called sawtooth signal that gives a time linear horizontal display on the CRT. The following controls influence the timebase:

- MTB/VAR and DTB adjust the horizontal time scale of MTB and DTB. The best MTB time scale is selected automatically if AUTO RANGE is active.
- The TB MODE key permits selection between auto (free run), trig(gered) and single (shot) mode of MTB. The SINGLE RESET key resets the MTB when in single shot mode.
- The DTB key permits selection of the operating modes of the DTB.
- The HOLD OFF control adjusts the period of time that the MTB does not start upon receipt of a trigger.
- The DELAY control adjusts the time delay between start of MTB and DTB.
- X POS controls the horizontal position of the signal display.

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2.5 CRT DISPLAY SECTION

This section determines the intensity and focusing of the signal on the screen. The intensity of trace and text/cursors can be adjusted separately with the controls TRACE INTENSITY and TEXT INTENSITY. The FOCUS control determines the sharpness of text and traces. Moreover focusing is controlled such that changes in intensity do not affect display sharpness.

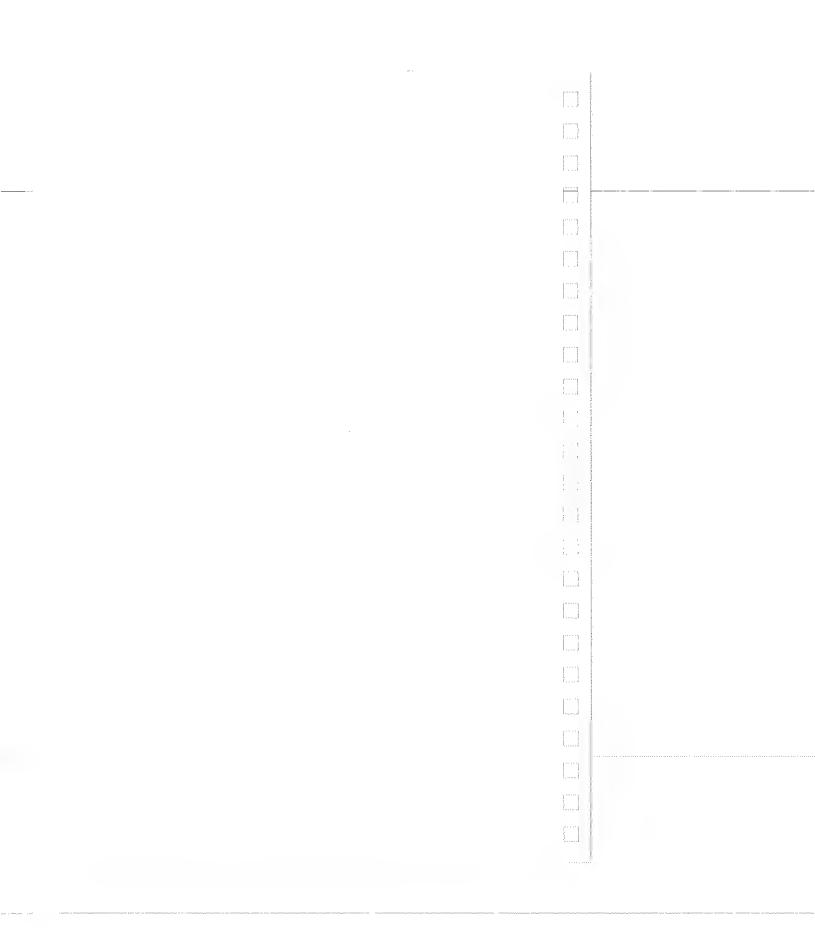
2.6 POWER SUPPLY

This POWER SUPPLY converts a wide range of line input voltages into stable supply voltages that feed the circuits in the oscilloscope. Also the very high voltages for the CRT are made by the power supply. Another output signal is used to trigger the MTB if 'line' is selected as trigger source. Memories in the oscilloscope are supplied by a MEMORY BACKUP battery if line voltage is switched off.

2.7 DIGITIZER SECTION

In DIGITAL MODE the CH1 ... CH4 input signals are applied to the DIGITIZER AND TEXT GENERATOR where they are digitized and stored in a memory. The signal storage is initiated by pulses from the TRIGGERING. Also the generation of text/cursors is done in the block DIGITIZER AND TEXT GENERATOR.

For display on the CRT, the digital information is converted into analog and applied to the final amplifiers for VERTICAL and HORIZONTAL deflection. The FOCUS and INTENSITY parts are controlled in a similar way. Switching between ANALOG MODE and DIGITAL MODE is done via the ANA/DIGI switches that are operated by the DIGITIZER AND TEXT GENERATOR. The switches are incorporated in the inputs of the output stages of Final Y, Final X, Intensity and Focusing.



3.1 General information

This procedure is intended to verify the instrument's functions with a minimum of test steps and actions required.

It is assumed that the operator doing this test is familiar with this kind of instruments and their characteristics.

WARNING: Before turning on the instrument, ensure that it has been installed in accordance with the instructions mentioned in Chapter 2 of the Operation Guide.

NOTE: The procedure does not verify every facet of the instrument's calibration; rather, it is concerned primarily with those parts of the instrument that are essential to measurement accuracy and correct operation. Removing the instrument covers is not necessary to perform this procedure. All checks are made from the outside of the instrument.

If this test is started a few minutes after turning on the instrument, test steps may be out of specification, due to insufficient warm-up time. Be sure to allow the full warm-up time of 30 minutes (under average conditions).

The check is set up in a logical sequence. For a complete check of every facet of the instrument's calibration, refer to the 'PERFORMANCE TEST' section in Chapter 4 of this Reference Manual (for qualified persons only).

The check can be used for different instrument types. Where differences exist, they are indicated (e.g., in the vertical channels). Those test steps can be skipped.

3.2 Preliminary settings of the controls

For ease of reading the following abbreviations are used:

- CW = Clockwise (rotation direction of a control)
- CCW = Counter Clockwise (rotation direction of a rotary control)
- CRT = Cathode Ray Tube (the oscilloscope's viewing area)
- MTB = MAIN TB
- DTB = DELAYED TIMEBASE, DEL'D TB

Trace alignment:

- Turn the oscilloscope on with the POWER ON OFF key.
- Press the STATUS and TEXT OFF keys simultaneously. This ensures that the oscilloscope is in the default mode. The default mode is the basis of this brief checking procedure.
- Press the AUTOSET key.
- Turn the TRACE INTENSITY control so that a clearly visible horizontal line appears on the CRT.
- Press the TEXT OFF key when no text is present on the CRT. Turn the TEXT INTENSITY control so that clearly visible text appears on the CRT.
- Turn the FOCUS control to make the line and text look as sharp as possible across the CRT area.
- Turn the GRATICULE ILLUMINATION control so that the desired illumination of the measuring graticule is obtained.
- Verify that the trace on the CRT is exactly parallel to the horizontal lines of the measuring raster; if not, correct this with a small screwdriver on the TRACE ROTATION control.

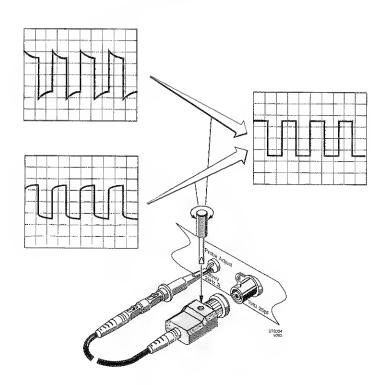
Instrument calibration.

Press the CAL key for two seconds: this starts the AUTOCALibration procedure. Wait until the normal display appears again. The oscilloscope calibration is now optimized.

Probe adjustment:

- Connect a 10 : 1 probe to the CH1 input.
- Connect the probe tip to the Probe Adjust output socket.
- Press the green AUTOSET key.
- Verify that a square-wave signal is displayed on the CRT.
- Verify that top and bottom of the square wave are straight: if not, this must be corrected by adjusting the probe. The correction is done with a small screwdriver. This adjustment is made in the box at the oscilloscope input side of the probe: refer to figure 3.1 for this.

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Note :

- The POS CH1, POS CH2, POS CH3, POS CH4 and X POS controls need occasional readjustment during this procedure to align the waveform with the measuring raster.
- Small readjustments of the TRACE INTENSITY, TEXT INTENSITY and FOCUS controls may also be necessary.
- Information about active instrument settings is indicated on the viewing area as shown in Fig. 3.2.

Repeatedly pressing the TEXT OFF key allows you to select the amount of information on the display.

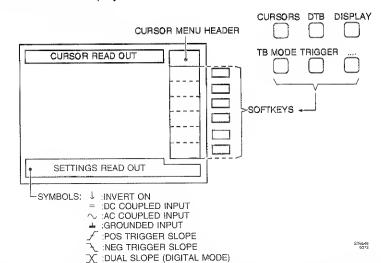


Figure 3.2 CRT viewing area, softkeys, menu keys, and symbols used in this chapter.

## 3.3 Vertical section

The vertical section consists of four channels CH1, CH2, CH3 and CH4. These are almost identical. The procedure is described for CH1. Steps for CH2, CH3 and CH4 are shown in parenthesies. To check all four channels the procedure must be done four times.

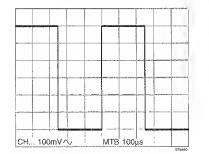
In some instrument versions, CH3 and CH4 have a limited range of input sensitivities. Differences in the keys for AC/DC input coupling, grounded trace (GND) and  $50\Omega$  input impedance may exist as well. This is indicated in the text. These test steps may be skipped.

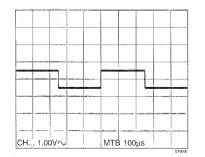
#### Proceed as follows:

Preparation:

- Connect a probe to the CH1 (CH2, CH3, CH4) input.
- Connect the probe tip to the Probe Adjust output socket.
- Press the AUTOSET key.
- The Probe Adjust output square-wave voltage should be well triggered. The waveform must be easy to read.
- Press the ANALOG key ('DIGITAL MODE' is displayed briefly): the oscilloscope is now in digital mode.

- Press the AUTOSET key again.
- Adjust the AMPL keys to an input sensitivity of 100mV/div; in case of an AMPL toggle key on CH3/CH4 the sensitivity must be 1.00 V.
- Adjust the MAIN TB TIME/DIV keys pair to 100 μs/div.
- Verify thet e square wave as indicated in Fig. 3.3 is displayed; in case of an AMPL toggle key on CH3/CH4, the vertical amplitude is 0.6 divisions instead of 6 divisions. The corresponding display is shown in Fig. 3.4.





#### Figure 3.3

Figure 3.4

Input coupling and POS control:

- Press the AC/DC/GND key so that dc input coupling (=) is obtained.
- Verify that this results in an upward signal shift. Fig. 3.5 shows this for channels with 100mV input sensitivity: the shift is 3 divisions. Fig. 3.6 shows this for channels with 1.00 V input sensitivity: the shift is 0.3 divisions..

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CH100mV=	MTB 100µs
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P****	 	
	1	
		МТВ 100µs

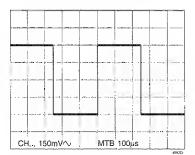
#### Figure 3.5

Figure 3.6

- Turn the POS control CCW until the displey of Fig. 3.3 or Fig. 3.4 is obtained agein.
- Press the AC/DC/GND key so that GND input coupling  $(\perp)$  is obtained.
- Verify that this results in a horizontal line in the lower part of the CRT.
- Turn the POS control CW until the line is in the middle of the screen.
- Press the AC/DC/GND key so that ac input coupling ( $\sim$ ) is obtained. The waveform as indicated in Fig. 3.3 or Fig. 3.4 is displayed again.

AMPL and VAR functions (this test is skipped for channels where AMPL is a toggle key):

- Press the lower AMPL key and verify that the signal amplitude is 3 divisions. The input sensitivity is 200mV/div.
- Press the upper AMPL key twice and verify that the amplitude is bigger than the screen height of 8 divisions. Use the POS control to shift the top and bottom of the signal into the screen area.
- Press both AMPL keys; this activates the VAR function. Now Input sensitivity can be adjusted in fine steps. The message 'VARIABLE ATTENUATION' is displayed briefly.
- Press the lower AMPL key until a readout of 150 mV is reached.
- Turn the POS control to position the waveform in the middle of the screen.
- Check for a display as indicated in Fig. 3.7.



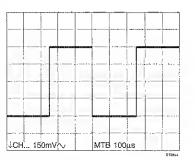


Figure 3.7

Figure 3.8

INV function:

- The following check is only required for CH2 and CH4.
- Press the INV key and check for a display as shown in Fig. 3.8.

AUTO RANGE function:

- The following check is only required for channels with an AUTO RANGE key. The AUTO RANGE function automatically selects the input sensitivity to the best possible amplitude of an input signal.
- Press the AUTOSET key. Verify that a stable signal is displayed.
- Press the upper AMPL key and select 20.0 mV/div. The signal amplitude is bigger now than the 8 divisions screen height.
- Press the channel's AUTO RANGE key and check that the input signal is again visible with an amplitude between 2 and 8.4 divisions.
- Press the lower AMPL key and select 2.00 V/div. The signal amplitude is very small and it may be that the instrument is not triggered.
- Press the channel's AUTO RANGE key and check that the input signal is again visible with an amplitude between 2 and 8.4 divisions.
- Press the ANALOG key to switch the instrument back to analog mode ("ANALOG MODE' appears briefly).

# 3.4 Horizontal section, MAIN TB and DELAYED TIME BASE.

#### Preparation:

- Connect a probe to the CH1 input.
- Connect the probe tip to the Probe Adjust output socket.
- Press the AUTOSET key.
- Adjust the AMPL keys to an input sensitivity of 100mV/div.
- Adjust the MAIN TB TIME/DIV keys to 100 μs/div.
- Verify that a square-wave as shown in Fig. 3.3 is displayed.

#### MTB trigger slope:

- Press the TRIG 1 key and verify that the displayed square-wave starts with a negative-going signal.
- Press the TRIG 1 key again and verify that the displayed square-wave starts with a positive-going slope as indicated in Fig. 3.3.

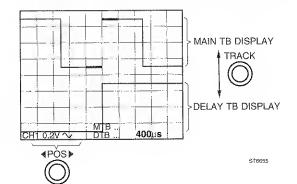
Time coeficients MAIN TB and VAR in analog mode:

- Press the left of the MAIN TB TIME/DIV keys and verify that the number of signal periods increases.
- Select 500 µs/division and verify that one signal period is displayed per division.
- Press both MAIN TB TIME/DIV keys: this activates the VAR mode. The message 'VARIABLE TIMEBASE' is displayed briefly.
- Press the right of the MAIN TB TIME/DIV keys until 250 μs is displayed.
- Verify that one signal period occupies 2 divisions.
- Press the left of the MAIN TB TIME/DIV keys until 500 μs is displayed.
- Verify that one signal period occupies 1 divison.
- Press both MAIN TB TIME/DIV keys: the VAR mode is switched off. The message '1-2-5 STEPS' is displayed briefly.
- Press the right of the MAIN TB TIME/DIV keys and verify that the number of signal periods decreases.
- Select 100 μs/division with the MAIN TB TIME/DIV keys and verify that the square wave is displayed as shown in Fig. 3.3.

#### MAIN TB and DELAYED TIMEBASE functions:

- Press the lower CH1 AMPL key so that an input sensitivity of 200 mV/division is obtained for channel 1.
- Use the CH1 POS control to position the signal in the upper half of the screen.
- Press the DTB menu key: the DELAYED TIMEBASE menu appears at the CRT softkeys.
- Select DEL'D TB 'on' and MAIN TB 'on' from this menu.
- Use the DELAYED TIMEBASE keys, to select 20.0 µs/division.

- Adjust the DELAY control in the DELAYED TIMEBASE section so that the display shown in Fig. 3.9 is obtained. For this the TRACK control must be edjusted so that MAIN TB is above the DEL'D TB display.
- Press the left of the DELAYED TIMEBASE TIME/DIV keys and verify thet the number of the displayed signal periods increases. The lowest TIME/DIV range is 100 µs/division.
- Press the right of the DELAYED TIME BASE TIME/DIV keys and verify that the number of displayed periods increases. Proceed until the time scele of 50.0 µs/division is reached.
- Select 'trig'd' from the DELAYED TIME BASE menu.
- Press the front panel key TRIG1 if the DELAYED TIMEBASE is not triggered on CH1. This is indicated in the lower right corner of the display.
- Use the  $\Delta$  control to adjust the trigger level of DELAYED TIMEBASE for
- a triggered display (signal on DEL'D TB time scale visible).





MAIN TB trigger slope and time coeficients in digital mode:

- Press the ANALOG key ('DIGITAL MODE' is displayed briefly). The oscilloscope is now in digital mode.
- Press the AUTOSET key.
- Adjust the AMPL keys to an input sensitivity of 100 mV/division.
- Adjust the MAIN TB TIME/DIV keys to 100 µs/DIV.
- Press the TRIG1 key and verify that the displeyed squere wave starts with a negative going signal.
- Press the TRIG1 key and triggering on the positive slope is obtained egain.
- Press the left side of the MAIN TB TIME/DIV keys and verify that the number of signal periods increases.
- Select 500 µs/division and verify that one signal period is displayed per division.

- Press the right side of the MAIN TB TIME/DIV keys and verify that the number of signal periods decreases.
- Use the MAIN TB TIME/DIV to selact 20.0 µs/division.

## AUTO RANGE function:

- Tha AUTO RANGE function of tha main time base (MAIN TB) adjusts the tima basa automatically so that 2 to 6 wavaform periods are displayed.
- Prass the AUTO RANGE key in tha time base section.
- Check that the time base is readjusted so that 2 to 6 waveform periods are displayed.
- Press the left of the MAIN TB TIME/DIV keys until MTB 2.00ms is displayed.
- Press the AUTO RANGE key in the time base section.
- Check that the time base is readjusted so that 2 to 6 waveform periods are displayed.
- Press the AUTO RANGE key in the time base section.
- Adjust MAIN TB TIME/DIV to 100µs/div.

MAIN TB and DELAYED TIMEBASE functions:

- Press the lower CH1 AMPL key so that an input sensitivity of 200 mV/division is obtained for channel 1.
- Use the CH1 POS control to position the signal in the upper half of the screen.
- Press the DTB menu key, the DELAYED TIME-BASE menu appears above the CRT softkeys.
- Select DEL'D TB 'on' and MAIN TB 'on' front from the DELAYED TIMEBASE menu.
- Use the DEL'D TB TIME/DIV to select 20.0 µs/division.
- Adjust the DELAY control in the DELAYED TIME BASE section so that the display of Fig. 3.9 is obtained. To do this the TRACK control must be adjusted such that MAIN TB is above the DEL'D TB display.
- Press the left side of the DELAYED TIME BASE TIME/DIV keys and verify that the number of displayed signal periods increases. The lowest TIME/DIV range is 100  $\mu$ s/division.
- Press the right side of the DELAYED TIME BASE TIME/DIV keys and verify that the number of displayed periods increases. Proceed until the time scale of 50.0 μs/division is reached.
- Salect 'trig'd' from the DELAYED TIME BASE manu.
- Prass tha front panal kay TRIG1 if the DELAYED TIMEBASE is not triggared on CH1. This is indicated in the lower right cornar of the display.
- Usa tha ∆ control to adjust tha triggar laval of DELAYED TIMEBASE for a triggerad display. The signal on tha DEL'D TB tima scala is visible.
- Prass the ANALOG kay to switch the instrument back to analog mode ('ANALOG MODE' is displayed briafly.

3 -	10 3 BRIEF CHECKING PROCEDURE	
3.	5 Horizontal section, X-deflection.	
	<ul> <li>connect a probe to the CH1 input.</li> <li>Connect the probe tip to the Probe Adjust output socket.</li> <li>Press the AUTOSET key.</li> <li>Press the AMPL keys to adjust to an Input sensitivity of 100mV/div.</li> <li>Press the MAIN TB TIME/DIV keys to adjust to 100 µs/div.</li> <li>Verify that a square wave as shown in flg. 3.3 is displayed.</li> </ul> defection check: <ul> <li>Press the CH2 ON key to turn CH2 on.</li> <li>Press the DISPLAY menu key.</li> <li>Press the X-DEFL softkey in the DISPLAY menu.</li> <li>Select 'on' and 'ch1' as X-SOURCE in the X-DEFL menu.</li> <li>Verify that two points with a horizontal distance of approximately 6 divisions are displayed.</li> </ul>	
<b>3.</b> Pri- - -	<ul> <li>6 Cursors</li> <li>eparation: <ul> <li>Connect a probe to the CH1 input.</li> <li>Connect the probe tip to the Probe Adjust output socket.</li> <li>Press the AUTOSET key.</li> <li>Adjust the CH1 AMPL key pair to obtain an input sensitivity of 100mV/div.</li> <li>Adjust the MAIN TB TIME/DIV keys to100 μs/div.</li> <li>Verify that a square wave with an amplitude of 6 divisions is displayed.</li> </ul> </li> </ul>	
- - - -	DLT cursors check: Press the CURSORS menu key; the CURSORS menu appears at the CRT softkeys. Use the softkeys to select 'on' and volt cursors (=). Verify that a dashed and a dotted horizontal line (the volt cursors) appear on the screen. Press the READOUT softkey and select $\Delta$ V from the menu. Press softkey RETURN. Use the TRACK control to position the dashed line exactly on the bottom level of the waveform. Use the $\Delta$ control to position the dotted line exactly on the top level of the waveform as shown in figure 3.10. Check for a volt cursor readout of approximately 600 mV in the top of the display area.	
		)

- Press the ANALOG key ('DIGITAL MODE' is displayed briefly). The oscilloscope is now in digital mode.
- Verify that the cursors are on the top and bottom of the waveform. If necessary, readjust them using the TRACK and ∆ controls.
- Check for a volt cursor readout of approximately 600 mV in the top of the display erea.

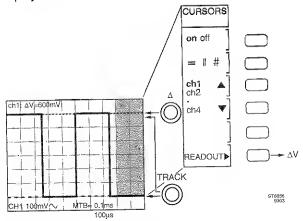
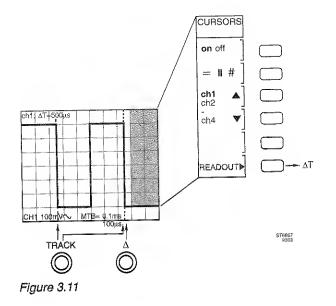


Figure 3.10



- 2		PERFORMANCE TEST	
CH1, e.g., CH1 (CH	al channels CH2, CH3, CH4 l2, CH3, CH4). This indicate owed by the tests for CH2, C	l appear in parentheses after s that the CH1 test should be 2H3 and CH4.	
Some of the tests a indicatad as necess	are not necassary for all four sary. The test step may then sts are done in either analog	oscilloscopa typas. This is be skipped.	
between analog and you enter eithar and	digital mode is done by pres alog or digital mode, the disp	ssing the ANALOG key. When	·····
	e use of a 10:1 probe is men delivered with the oscillosco	tioned, must be done with the	
probe type such as	denvered with the oscillosoc	ање.	
.2 RECOMME	NDED TEST EQUIP	MENT	
Note: the digital mu	ltimeter and oscilloscope are	e not required for this test.	
ype of instrument	Required specification	Example of recommended instrument	,
Sine wave/s Ampl: 020 DC offset -5 Rise time <3	Freq: 1 Hz10 MHz Sine wave/square-wave Ampl: 020V (pp)	PM5134 or PM5138	
	minpi ozov (pp)		£
	DC offset -5+5V Rise time ≤30 ns Duty cycle 50%		
	DC offset -5+5V Rise time ≤30 ns Duty cycle 50% Freq: 50 kHz250 MHz Constant pp. amplitude	Tektronix SG 503	
ine wave generator	DC offset -5+5V Rise time ≤30 ns Duty cycle 50% Freq: 50 kHz250 MHz Constant pp. amplitude of 120 mV to 3V.		
ine wave generator Constant amplitude	DC offset -5+5V Rise time ≤30 ns Duty cycle 50% Freq: 50 kHz250 MHz Constant pp. amplitude	Tektronix SG 503 Tektronix SG 504 To check the trigger sensitivity in PM3392A/94A	
ine wave generator Constant amplitude Sine wave generator	DC offset -5+5V Rise time ≤30 ns Duty cycle 50% Freq: 50 kHz250 MHz Constant pp. amplitude of 120 mV to 3V. Freq: 50 kHz300 MHz. Constant pp. amplitude of 120 mV to 3V	Tektronix SG 504 To check the trigger	
ine wave generator Constant amplitude sine wave generator Square-wave	DC offset -5+5V Rise time ≤30 ns Duty cycle 50% Freq: 50 kHz250 MHz Constant pp. amplitude of 120 mV to 3V. Freq: 50 kHz300 MHz. Constant pp. amplitude	Tektronix SG 504 To check the trigger sensitivity in PM3392A/94A	
ine wave generator Constant amplitude sine wave generator Square-wave	DC offset -5+5V Rise time ≤30 ns Duty cycle 50% Freq: 50 kHz250 MHz Constant pp. amplitude of 120 mV to 3V. Freq: 50 kHz300 MHz. Constant pp. amplitude of 120 mV to 3V For ampl. calibration: Freq: 1 kHz	Tektronix SG 504 To check the trigger sensitivity in PM3392A/94A	
Sine wave generator Constant amplitude Sine wave generator	DC offset -5+5V         Rise time ≤30 ns         Duty cycle 50%         Freq: 50 kHz250 MHz         Constant pp. amplitude         of 120 mV to 3V.         Freq: 50 kHz300 MHz.         Constant pp. amplitude         of 120 mV to 3V.         Freq: 50 kHz300 MHz.         Constant pp. amplitude         of 120 mV to 3V         For ampl. calibration:         Freq: 1 kHz         Ampl: 10 mV50 mV         For rise time         measurements:         Freq: 1 MHz         Ampl: 10900 mV	Tektronix SG 504 To check the trigger sensitivity in PM3392A/94A	
Constant amplitude sine wave generator Constant amplitude sine wave generator Square-wave callbration generator	DC offset -5+5V         Rise time ≤30 ns         Duty cycle 50%         Freq: 50 kHz250 MHz         Constant pp. amplitude         of 120 mV to 3V.         Freq: 50 kHz300 MHz.         Constant pp. amplitude         of 120 mV to 3V         For ampl. calibration:         Freq: 1 kHz         Ampl: 10 mV50 mV         For rise time         measurements:         Freq: 1 MHz	Tektronix SG 504 To check the trigger sensitivity in PM3392A/94A	
sine wave generator Constant amplitude sine wave generator Square-wave	DC offset -5+5V         Rise time ≤30 ns         Duty cycle 50%         Freq: 50 kHz250 MHz         Constant pp. amplitude         of 120 mV to 3V.         Freq: 50 kHz300 MHz.         Constant pp. amplitude         of 120 mV to 3V.         Freq: 50 kHz300 MHz.         Constant pp. amplitude         of 120 mV to 3V         For ampl. calibration:         Freq: 1 kHz         Ampl: 10 mV50 mV         For rise time         measurements:         Freq: 1 MHz         Ampl: 10900 mV	Tektronix SG 504 To check the trigger sensitivity in PM3392A/94A	

## PERFORMANCE TEST

Time marker generator	Repetition rate: 0.5s2 ns	Tektronix TG 501
Digital multimeter	Wide voltage and current ranges.	PM2525 with AC, DC and resistance ranges. High voltage probe. Required: 1% accuracy, PM9246
Variable voltage transformer (VARIAC)	Well insulated output voltage 90264V (ac)	Order. number 2422 529 00005
TV pattern generator with video output		
Oscilloscope	The bandwidth must be the same or higher than the bandwidth of the instrument under test.	РМ3394А
50Ω cables, 75Ω cable, 50Ω terminations, 75Ω termination, 10:1 attenuator, T-piece, power splitter	Tektronix and Fluke BNC types for fast rise time square-wave, high frequency sine wave and other applications.	TEK 012-0482-00 TEK 012-0074-00 TEK 011-0049-01 TEK 011-0055-01 TEK 011-0059-02 PM9067 PM9584/02
BNC/Probe tip adapter	For Bandwidth check in PM3392A	Ord. nr. 5322 263 50022

4.3 TEST PROCEDURE         4.3.1 Preliminary settings         Test equipment:	۱
4.3.1 Preliminary settings	
Test equipment:	1
News	
None Settings/procedure and requirements:	
<ol> <li>If not present install 2 penlight (LR6) back up batteries in the holder at the rear panel of the oscilloscope.</li> <li>Turn on the oscilloscope under test.</li> <li>Press the STATUS and TEXT OFF keys simultaneously. This assures that the oscilloscope follows the default reaction when the green AUTOSET key is pressed. You can verify that the oscilloscope is in analog mode by pressing the RUN/STOP key. If you are in analog mode, the message "PLEASE FIRST SWITCH TO DSO' is displayed. The now following steps are applicable for PM33924 and PM3394A.</li> <li>Press the UTILITY menu key to display the UTILITY menu.</li> <li>Press the UTILITY menu key to display the UTILITY AUTOSET menu.</li> <li>Press the relevant softkey to put the oscilloscope in the 'userprog' mode; the text 'userprog' must be intensified.</li> <li>Press softkey VERT.</li> <li>Select with softkey TIMΩ / 50Ω / unaffect' the 'unaffect' position.</li> <li>Check for the instrument settings in the lower part of the viewing area: when not available press TEXT OFF until the maximum amount of information is displayed.</li> </ol>	

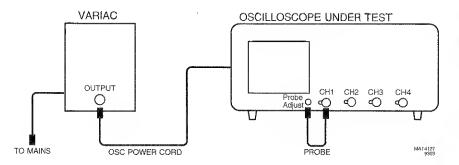
## 4.3.2 Power supply

This test checks the proper operation of the power supply at all possible line voltages.

Test equipment:

Variable voltage trensformer (VARIAC)

Test set-up:

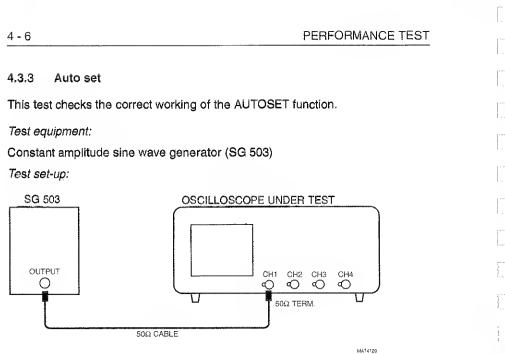


#### Settings/procedure:

- Adjust the input line voltage to the oscilloscope (output from VARIAC) to a desired value between 100 and 240V (rms), frequency 50...400 Hz.
- 2 Press POWER ON on the oscilloscope.
- 3 Apply the Probe Adjust signal from the front panel of the oscilloscope to input CH1, e.g., by means of a 10:1 probe.
- 4 Press the green AUTOSET key.

#### Requirements:

- Verify that the oscilloscope starts at any input voltage between 100 and 240V; in particular the line voltages 100, 120, 220 and 240V must be checked.
- 2 Verify that the instrument's performance does not change over the indicated voltage renge; and that the displayed Probe Adjust signal is distortion-free and has equal intensity.
- 3 Press the ANALOG key ('DIGITAL MODE' is displeyed briefly), and verify that the instrument's performance does not change in digital mode at the indicated line voltages (100, 120, 220 and 240V). The displayed Probe Adjust signal must be free from distortion.



## Settings/procedure:

- 1 Apply a 10 MHz sine wave signal of 600 mV (pp into 50 $\Omega$ ) to input CH1;.
- Press the green AUTOSET key. Use a 50Ω termination at the end of the coax cable. For instruments with switchable 50Ω input impedance (attainable via VERT MENU key) it is recommended to use the internal termination (when active, the text 'LZ' appears in the lower part of the viewing area). For instruments without internal termination, an external termination should be used.

#### Requirements:

- Verify that the displayed waveform is stable and properly triggered. Amplitude should be within the screen area. Horizontally some signal periods should be displayed.
- 2 Repeat the same settings and procedure for CH2, CH3 and CH4.
- 3 Press the ANALOG key to return to analog mode. The message 'ANALOG MODE' appears briefly.
- 4 Repeat the AUTOSET check in the analog mode for CH2, CH3, and CH4.

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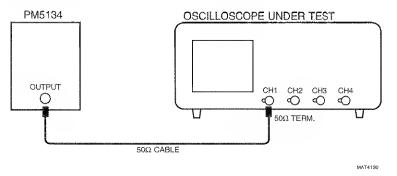
## 4.3.4 Orthogonality

This test checks the angle between the horizontel end vertical deflection plates (orthogonality).

## Test equipment:

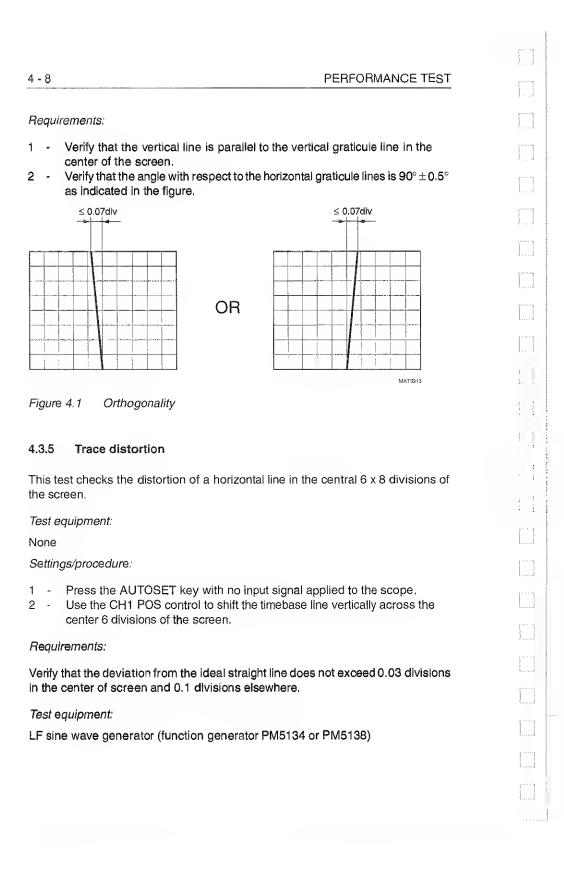
LF sine weve generator (function generator PM5134 or PM5138)

Test set up:

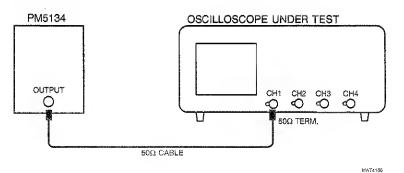


#### Settings/procedure:

- Press the CAL key for a few seconds to start the autocal procedure. This takes approximately 4 minutes. When ready, the oscilloscope is fine tuned to optimal accuracy.
- 2 Apply a 50 Hz sine wave signal of 8V (pp into 50Ω) to input CH1;
- 3 Press the AUTOSET key and adjust the input signal to a trace- height of 8 div (CH1 in 1V/div). Use a 50Ω termination at the end of the cable. For instruments with switchable 50Ω input impedance the use of the internal termination is recommended.
- 4 Activate the GND function and verify that the straight line is exactly parallel to the horizontal graticule lines. If not, readjust the TRACE ROTATION,
- 5 Switch the GND function off and verify that a signal of 8 divisions is displayed.
- 6 Press the DISPLAY menu key.
- 7 Press the X-DEFL softkey.
- 8 Select 'on' and 'ch2' from the X-DEFL menu.
- 9 Use the X POS control to move the verticel line to the center of the screen.



## Test set-up:



## Settings/procedure:

- 1 Apply a 50 Hz sine wave signal of 8V (pp into  $50\Omega$ ) to input CH1;
- Press the AUTOSET key and adjust the input signal to an amplitude of 8 divisions (CH1 in 1V/div). Use an external 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature.
- 3 Using the CH1 POS control, adjust the display around the center of the screen.
- 6 Press the DISPLAY menu key.
- 7 Press the X-DEFL softkey.
- 8 Select 'on' and 'ch2' from the X-DEFL menu.
- 9 Use the X POS control to shift the vertical line across the middle eight divisions of the screen.

## Requirements:

Verify that the deviation from the ideal straight line does not exceed 0.03 divisions in the center of screen and 0.1 divisions elsewhere.

## 4.3.6 Vertical deflection; deflection coefficients

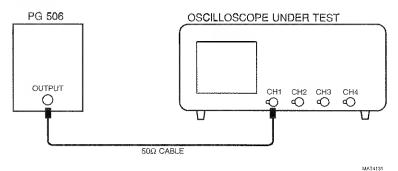
The vertical deflection coefficients of channels CH1, CH2, CH3, and CH4 are checked by means of a calibrated signal.

## Test equipment:

Square-wave calibration generator (PG 506)

Test set up:

4 - 10



## Settings/procedure:

- Apply a 1 kHz square-wave signal of 20 mV to input CH1. Set the generator in position STD AMPL. The generator must <u>not</u> be terminated with 50Ω (the text 'LZ' must not be visible in the lower part of the viewing area).
- 2 Press the green AUTOSET key.
- 3 Set CH1 to 5 mV/div and to DC input coupling. The waveform must be in the vertical middle of the screen.
- 4 Press the ACQUIRE menu key,
- 5 Select BW LIMIT 'on' from the VERT MENU key.
- 6 Press the TRIGGER menu key.
- 7 Select noise 'on' and 'hf-rej' from the TRIGGER MAIN TB menu.
- Change the input voltage and the setting of CH1 according to table I and verify that the amplitude of the signal agrees with this table. The signal should remain positioned in the vertical center of the screen.

Note: Only the input sensitivities essential for input accuracy are checked.

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#### Requirements:

table I.

Input voltage (pp)	Setting	Requirements analog mode	Requirements digital mode
20 mV	5 mV	3.944.06 div (±1.3%)	3.924.08 div (±2%)
50 mV	10 mV	4.935.07 div (±1.3%)	4.95.1 div (±2%)
1V	0.2V	4.935.07 div (±1.3%)	4.95.1 div (±2%)
5V	1V	4.93 <b>5.07</b> div (±1.3%)	4.95.1 div (±2%)

Repeat the settings/procedure in table I for CH2, CH3 and CH4. Use table II for CH3 and CH4 in PM3392A and PM3382A.

#### table II.

Input voltage	Setting	Requirements	Requirements
(pp)		analog mode	digital mode
0.5V	0.1V	4.935.07 div (±1.3%)	4.95.1 (±2%)
2V	0.5V	3.944.06 div (±1.3%)	3.924.08 (±2%)

 Press the ANALOG key ('DIGITAL MODE' is displayed briefly), and repeat the tests in this chapter for the digital mode.

- Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to analog mode.

## 4.3.7 Vertical deflection; variable gain control range (continuation of 4.3.6)

This test checks the vertical VARiable gain control.

## Settings/procedure;

- 1 Apply a square-wave signal of 0.2V to input CH1 and press AUTOSET.
- 2 Set CH1 to 50 mV/div and input coupling to DC. Using the CH1 POS control, center the waveform in the screen.
- Select the VARIable mode by simultaneously pressing both AMPL keys.
   The readout changes into 50.0 mV/div.
- 4 Press the mV key to adjust an input sensitivity of 40.0 mV/div.

#### Requirements:

- Verify that the displayed amplitude is between 4.88 and 5.14 divisions (+/- 2.8%).
- 2 Repeat the settings and procedure for CH2. For the PM3394A and PM3384A repeat the same steps for CH3 and CH4.

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		· · · · · · · · · · · · · · · · · · ·
4 - 12	PERFORMANCE TEST	
4.3.8 Vert	ical deflection; Input coupling (continuation of 4.3.7)	
	iles the operation of the AC input coupling. Also, the operation of the ) function is checked.	
Settings/proc	sedure:	
AMPL	h the CH1 VARiable mode off by simultaneously pressing both "VAR keys. The readout changes to 50 mV. sensitivity is 50 mV/div; the vertical deflection is now 4 divisions.	
		1
Requirement		
1 - Activa displa	ate the CH1 GND function and verify that a horizontal line is ayed.	
2 - Selec signal	t the AC input coupling and verify that a 4 divisions square-wave I is displayed. Center this signal in the middle of the screen.	
signa	t the DC input coupling and verify that the 4 divisions square-wave I moves up. This shift is caused by the signal's positive dc onent: this component is not blocked in DC coupled mode.	
Repeat the s PM3382A, th	ettings and procedure for CH2, CH3, and CH4. In the PM3392A and ne test of the GND and AC function is skipped for CH3 and CH4.	
4.3.9 Ver	tical cursor accuracy (continuation of 4.3.8.)	**************************************
This test ver	ifies the accuracy of the voltage cursors	
Settings/pro	cedure:	
	ge the generator output voltage to 0.1V. / this voltage to CH1.	
4 - Selec	th CH1 to ON, and switch the other channels off. t DC coupled input and 20 mV/division for CH1. th CL1 as triange course (TPIC 1)	
6 - Use t	ct CH1 as trigger source (TRIG 1). the POS control to center the 5 division square wave on the dotted ontal lines of the graticule.	
7 - Press	s the CURSORS menu key. ct 'on' and volt cursors (=) from in the CURSORS menu.	<u>]]</u>
	ct $\Delta$ V from the READOUT menu.	
		]

## 4 - 13

### Requirements:

- 1 Use the TRACK and  $\Delta$  controls to position both cursor lines exactly on top and bottom of the signel. Check for a cursor reedout between 98.4 end 101.6 mV.
- 2 Press the ANALOG key ('DIGITAL MODE' is displayed briefly) and repeet the check in this chapter for the digitel mode.
- 3 Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to analog mode.

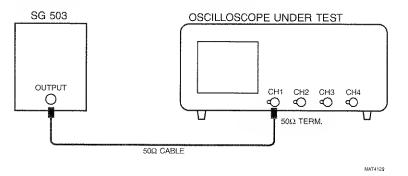
## 4.3.10 Vertical deflection; high-frequency response

This test verifies the upper transition point of the vertical bandwidth.

## Test equipment:

Constant amplitude sine wave generator (SG 503)

Test set-up:



#### Settings/procedure:

- Apply a 50 kHz sine wave signal of 600 mV (pp into 50Ω) to input CH1, and press the AUTOSET key.
- Use an external 50Ω termination. Use the internal termination of the oscilloscope, when evailable (if active, the text 'LZ' is visible in the lower part of the viewing area).
- 3 Set CH1 to 0.1V/div.
- 4 Adjust the input signal to en amplitude of exactly 6 divisions.
- 5 Slowly increase the frequency to 200 MHz (PM3392A, PM3394A) or 100 MHz (PM3382A, PM3384A) end verify that the displayed amplitude does not drop below 4.2 divisions. Internal 50Ω termination is attainable via the VERT MENU key (PM3392A/94A).

4 - 14	PERFORMANCE TEST	
<ul> <li>6 - Switch the frequency of the sine wave signal bac</li> <li>7 - Press the ACQUIRE menu key.</li> <li>8 - Select BW LIMIT 'on' via the VERT MENU key.</li> <li>9 - Slowly increase the frequency to 20 MHz and ve deflection has decreesed to 4.2 div epproximatel</li> <li>10 - Switch the bendwidth limiter to 'off'.</li> </ul>	rify that the vertical	
Requirements:		
The vertical deflection must be 4.2 divisions or more. For requirement is 4.2 div approximately at 20 MHz.	the bandwidth limiter the	
Repeat the above settings and procedure for CH2, CH3		
for CH3 and CH4 in PM3392A must be done via the 10:1 cable. Oscilloscope in 1V/div and generator voltage 6 V	pp Into 50 $\Omega$ . Termination	
resistor directly at generator output. Use a BNC / probe termination and 10:1 probe.	tip adapter between	
- Press the ANALOG key ('DIGITAL MODE' is displayed tests in this chapter for the digital mode. Adjust the I		
required.		
4.3.11 Vertical deflection; low-frequency response	e i i	
This test verifies the lower transition point of the vertica	I bandwidth.	
Test equipment:		
LF sine wave generator (Function generator PM5134 o	r PM5138)	
Test set up:	· · · · · ·	
PM5134 OSCILLOSCOPE UNDE		
OUTPUT CH1 CH	H2 CH3 CH4	
50Ω CABLE		
	M#T4190	•*•
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## 4 - 15

Settings/procedure:

- Apply a 5 kHz sine weve signel of 600 mV (pp into 50Ω) to input CH1, and press the AUTOSET key.
- 2 Use en external 50Ω termination. Use the internal termination when available (via the VERT MENU key).
- 3 Set CH1 to 0.1V/div.
- 4 Adjust the input signal to an amplitude of exactly 6 divisions.
- 5 Lower the frequency to 10 Hz end verify that the displayed amplitude does not drop below 4.2 divisions.

Requirements:

The vertical deflection must be 4.2 divisions or more.

Repeat the above settings and procedure for CH2, CH3, and CH4.

Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to analog mode.

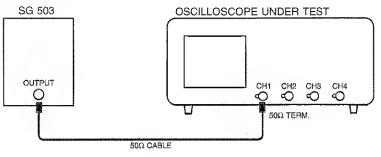
### 4.3.12 Vertical deflection; dynamic range at 25/50 MHz

The oscilloscope must be capable of displaying signal amplitudes that are larger than the screen. In practice, a low frequency signal with an amplitude equivalent to 24 divisions must be displayed with no distortion.

Test equipment:

Constant amplitude sine wave generator (SG 503)

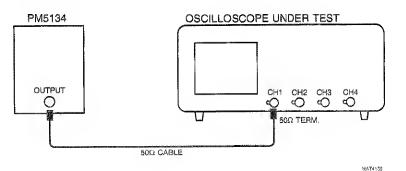
Test set up:



MAT4129

	(  , [.] )
4 - 16 PERFORMANCE TEST	······
Settings/procedure:	
1 - Apply a 50 MHz (PM3392A/94A) or 25 MHz (PM3382A/84A) sine weve	
signel of 2.4 V(pp into $50\Omega$ ) to input CH1 and press the AUTOSET key. 2 - Use a $50\Omega$ termination. Use the internal terminetion when avaiable.	
<ul> <li>3 - Set CH1 to 0.1V/div.</li> <li>4 - Using the CH1 POS control, shift the sine wave vertically over the screen.</li> </ul>	(·····)
Requirements:	الا ب
Verify that top and bottom of the sine-wave signal of 24 divisions in amplitude can be displayed with no distortion.	
Repeat the above settings and procedure for CH2, CH3, and CH4.	
4.3.13 Vertical deflection; dynamic range at 100/200 MHz (continuation of 4.3.12)	[]
In this test, the dynamic range of the amplifier is checked at a high frequency.	
Settings/procedure:	
<ol> <li>Apply a 200 MHz (PM3392A, PM3394A) or 100 MHz (PM3382A, PM3384A) sine-wave signal of 0.8 V(pp into 50Ω) to input CH1.</li> <li>Press the AUTOSET key, and set CH1 to 0.1V/div.</li> <li>Use a 50Ω termination. Use the internal termination when available.</li> <li>Set the amplitude to exactly 8 divisions.</li> </ol>	
Requirements:	· · · · · · · · · · · · · · · · · · ·
Verify that the sine wave of 8 divisions in amplitude is displayed with no distortion.	ii - i
Repeat the above settings and procedure for CH2, CH3, and CH4.	I
4.3.14 Vertical deflection; position range	[]
The range of the vertical shift is checked with a sine-wave signal of 8 divisions in amplitude.	ыллай (****) — 11 ()
Test equipment	
LF sine weve generator (function generator PM5134 or PM5138)	

Test set up:



## Settings/procedure:

- Apply a 1 kHz sine wave signal with an amplitude of 0.8 V(pp into 50Ω) to input CH1.
- 2 Press the AUTOSET key and set CH1 to 0.1V/div.
- 3 Use a 50 $\Omega$  termination. Use the internal termination when available.

#### Requirements

Turn the CH1 POS control fully clockwise and counterclockwise and verify that top and bottom of the 8 divisions signal can be positioned outside the graticule.

Repeat the above settings and procedure for CH2, CH3, and CH4.

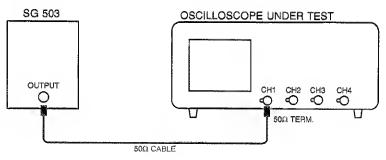
# 4.3.15 Vertical deflection; crosstalk between channels at 100/200 MHz

At higher frequencies there exists some crosstalk between any two channels. In the following test, crosstalk is verified at a high frequency.

#### Test equipment:

Constant amplitude sine wave generator (SG 503)

Test set up:



#### MAT4129

## Settings/procedure:

- Apply a 200 MHz (PM3392A, PM3394A) or 100 MHz (PM3382A, PM3384A) sine-wave signal of 0.8 V(pp into 50Ω) to input CH1.
- 2 Press the AUTOSET key.
- 3 Use a 50 $\Omega$  termination. Use the internal termination when available.
- 4 Switch all channels ON.
- 5 Set all channels to 0.1 V/div.
- 6 Adjust the generator to a signal amplitude of 8 div.
- 7 Activate the GND function of CH2, CH3, and CH4.

## Requirements:

Verify that the displayed amplitude the channels with no input signal applied is less than 0.16 divisions, (better than 50:1).

Repeat the above settings and procedure:

- Input signal applied to CH2. CH1, CH3, and CH4 input GND,
- Input signal applied to CH3. CH1, CH2, and CH4 input GND.
- Input signal applied to CH4. CH1, CH2, and CH3 input GND.
- Press the ANALOG key ('DIGITAL MODE' is displayed briefly) and repeat the tests in this chapter for the digital mode.
- Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to analog mode.

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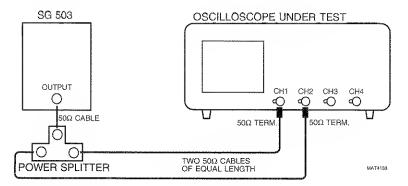
## 4.3.16 Vertical deflection; common mode rejection ratio at 1 MHz

The common mode rejection ratio (CMRR) is a measure of susceptibility to common mode signals. This susceptibility is verified in this test.

Test equipment:

- HF constant amplitude sine wave generator (SG 503)
- Power splitter

Test set up:



Settings/procedure:

- 1 Use a power splitter and two cables of equal length to CH1 and CH2. Apply a 1 MHz sine-wave signal of  $0.6 \text{ V}(\text{pp into } 50\Omega)$  to inputs CH1 and CH2.
- 2 Press the AUTOSET key.
- Use 50Ω terminations. Use the internal terminations when available (via VERT MENU key).
- 4 Set CH1 and CH2 to 0.1V/div and adjust the generator voltage for a deflection of 6 divisions.
- 5 Set CH1 and CH2 to DC input coupling.
- 6 Press the CH1+CH2 key to activate the 'added' mode.
- 7 Press the INV key of CH2; the result is the display of CH1-CH2.
- 8 Press the ON keys of CH1 and CH2; this switches CH1 and CH2 off and only the differential signal (CH1 CH2) is now visible.
- 9 Readjust the VAR function of CH1 or CH2 for minimum amplitude.

#### Requirements

- Verify that the trace-height of the CH1-CH2 differential signal is less than 0.06 divisions.
- Repeat the above settings and procedure for CH3 and CH4 (not required for PM3382A-PM3392A).

4	- 20	PERFORMANCE TEST	
*******			
4.	3.17	Vertical deflection; common mode rejection ratio at 50 MHz (continuation of 4.3.16)	
		ommon mode rejection ratio (CMRR) indicates the susceptibility to common signals at higher frequencies. The susceptibility is verified in this test.	
Se	ettin	gs/procedure:	1
1		Use a power splitter and two cables of equal length to CH1 and CH2. Apply a sine-wave signal of 50 MHz with an amplitude of 0.6 V(pp into $50\Omega$ ) to inputs CH1 and CH2. Press the AUTOSET key.	
2 3 4	-	Use a $50\Omega$ termination. Use the internal termination when available. Set CH1 and CH2 to 0.1 V/div and adjust the generator voltage for a deflection of 6 divisions.	
5 6 7 8	-	Set CH1 and CH2 to DC input coupling. Press the CH1+CH2 key; to activate the added mode. Press the INV key of CH2; the result is the display of the differential signal of CH1-CH2. Press the ON keys of CH1 and CH2; this switches CH1 and CH2 off and	
9	-	only the differential signal of CH1 CH2 display is now visible. Readjust the VAR function of CH1 or CH2 for minimum amplitude.	
H	equi	rements:	
1	-	Verify that the amplitude of the CH1-CH2 differential signal is less than 0.24 divisions.	
2	-	Repeat the above settings and procedure for CH3 and CH4 (not required for PM3382A/PM3392A).	
			l,

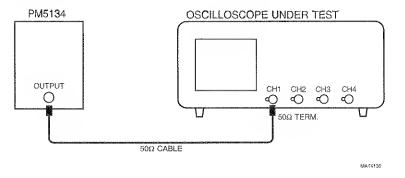
## 4.3.18 Vertical deflection; LF linearity

The linearity of the vertical amplifier is checked by moving a signal with a fixed amplitude vertically over the entire screen area.

## Test equipment

LF squere-weve generator (function generator PM5134 or PM5138)

Test set up:



#### Settings/procedure

- 1 Apply a 50 kHz square-wave signal of 200 mV(pp into 50Ω)to input CH1.
- 2 Press the AUTOSET key and set CH1 to 0.1V/div.
- 3 Use a  $50\Omega$  termination. Use the internal termination when available (via VERT MENU key).
- 4 Move the square-wave signal to the vertical center of the screen.
- 5 Adjust the generator output so that the displayed amplitude is exactly 2 divisions.
- 6 Use the CH1 POS control to shift the signal across the central 6 divisions of the screen,

#### Requirements

- Verify that the amplitude in the two upper and lower divisions is between 1.96 ...2.04 divisions (+ or - 2%).
- 2 Repeet the ebove settings end procedure for CH2, CH3 and CH4.
- 3 Press the ANALOG key ('DIGITAL MODE' is displayed briefly) and repeet the check in this chapter for the digital mode. The requirement for the digital mode is a vertical amplitude in the upper and lower screen aree between 1.94 ... 2.06 divisions (+ or 3%).
- Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to analog mode.

## 4.3.19 Vertical deflection; visual signal delay

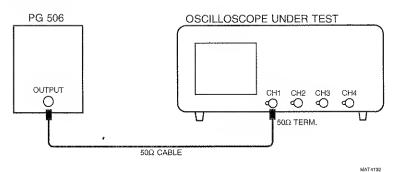
Many applications require that the leading edge of a fast pulse triggering the oscilloscope be made visible. A fixed amount of signal delay is introduced in the vartical channels of this instrument to allow the timebase to start before the triggering leading edge causes vertical deflection to occur. This dalay is verified in tha following test.

## Test equipment

Square-wave calibration generator (PG 506)

Test set-up:

4 - 22



## Settings/procedure:

- 1 Apply a signal with a fast rise time of less than 1 ns and an amplitude of 0.5V (into  $50\Omega$ ), and a frequency of 1 MHz, to input CH1. Set the generator in the FAST RISE position.
- 2 Press the AUTOSET button and set CH1 to 0.1V/div.
- 3 Use a 50Ω termination. Use the Internal termination when provided (via VERT MENU key).
- 4 Set the MAIN TB TIME/DIV to 50.0 ns/div.
- 5 Press the MAGNIFY key and turn the X POS control to display the leading edge.
- 6 Turn the TRACE INTENSITY control clockwise for maximum intensity.
- 7 Press the TRIGGER menu key.
- 8 Salact level pp 'off' and 'dc' trigger coupling from the TRIGGER MAIN TB menu.
- 9 Adjust TRIGGER LEVEL for a triggered display and maximum visible signal delay.

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Requirements

Verify that the visible signal delay is at least 15 ns (3 divisions).

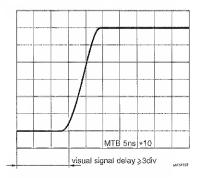


Figure 4.2 Visual signal delay

4.3.20 Vertical deflection; base line instability

In the following test, several adjustments of balance, offset and jump, are checked.

Test equipment

None

Settings/procedure and requirements:

- 1 Press the AUTOSET key (no input signal) and set CH1 to 5V/div.
- Use the CH1 POS control to position the trace in the vertical middle of the screen.
- Press both CH1 AMPL keys simultaneously to select the VARiable mode. The readout changes to 5.00V. The input sensitivity can be adjusted now in very fine steps between 2 mV and 12.5V/div.
- Press the 'V' key and verify that the base line jump is not more than
 0.2 divisions between 5.00V to 12.5V/div.
- 5 Press the 'mV' key and verify that the base line jump is not more than 0.2 divisions between 12.5V/div to 5 mV/div.
- 6 Press the ON keys of CH2 and CH1; CH2 is now on and CH1 Is off.
- 7 Using the CH2 POS control, position the trace in the vertical middle of the screen.

PERFORMANCE TEST

- Press both CH2 AMPL keys simultaneously to select the VARiable mode. The readout changes to 5.00V. The input sensitivity can be adjusted now in very fine steps between 2 mV and 12.5V/dlv.
- 9 Press the 'V' key and verify that the base line jump is not more than
 0.2 divisions between 5.00V to 12.5V/div.
- 10 Press the 'mV' key and verify that the base line jump does not 0.2 divisions between 12.5V/div to 5 mV/div.
- 11 Press the INV key repeatedly and verify that the base line jump is not more than 0.2 divisions.

For the PM3394A and PM3384A repeat the above procedure for CH3 and CH4. The CH3 settings are equal to those of CH1; the CH4 settings are equal to CH2.

For the PM3392A and PM3382A the following steps are required to check CH3 and CH4:

- 1 Press the ON keys of CH3 and CH2; CH3 is now on and CH2 is off.
- 2 Use the CH3 POS control to position the trace in the vertical center of the screen.
- 3 Press the CH3 AMPL key repeatedly and verify that the base line jump does not exceed 0.2 divisions.
- 4 Press the ON keys of CH4 and CH3; CH4 is now on and CH3 is off.
- 5 Using the CH4 POS control, position the trace in the vertical center of the screen.
- 6 Press the CH4 AMPL key repeatedly and verify that the base line jump does not exceed 0.2 divisions.
- 7 Press the INV key repeatedly and verify that the base line jump does not exceed 0.2 divisions.

4.3.21 Delay difference between vertical channels

The delay difference between CH1, CH2, CH3, and CH4 is checked here.

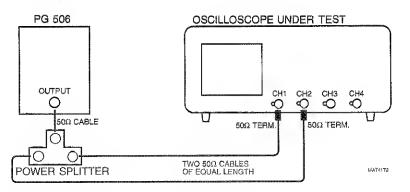
Test equipment:

4 - 24

Square wave calibration generator (PG 506) Power splitter

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Test set up:



Settings/procedure PM3392A, PM3394A, PM3382A, PM3384A:

- Apply a square-wave signal with a fast rise time of less than 1 ns, and an amplitude of 0.5V (into 50Ω), with a frequency of 1 MHz, to inputs CH1 and CH2. The generator must be set in the FAST RISE position.
 Use a power splitter and two cables of equal length to CH1 and CH2.
- 2 Press the AUTOSET key.
- Use 50Ω terminations. Use the internal terminations when available (via VERT MENU key).
- 4 Set CH1 and CH2 to 0.1V/div and input coupling to DC.
- 5 Press the MAGNIFY keys and set the MAIN TB TIME/DIV to 2.00 ns/div (PM3392A, PM3394A) or to 5.00 ns/div (PM3382A, PM3384A).
- 6 Press the TRIGGER menu key.
- 7 Select level-pp 'off' and 'dc' trigger coupling from the related menu.
- 8 Press the TB MODE menu key.
- 9 Select 'trig' from the related menu.
- 10 Adjust TRIGGER LEVEL for a triggered display of the leading edge.
- 11 Using the X POS control, position the leading edges of the signals in the horizontal center of the screen.
- 12 Using both CH1 and CH2 POS controls, adjust the vertical position of each trace between the dotted 0% and 100% lines. The signals appear to be superimposed.

Requirements

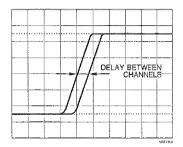
Verify that the delay difference between the two displayed signals is less then 0.25 ns. This equels 0.13 divisions in PM3392A and PM3394A or 0.05 divisions in PM3382A and PM3384A.

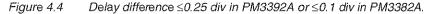
4 - 26	PERFORMANCE TEST		
Repeat the above settings and procedu	ire for CH2 and CH4	1	
DELAY BETWEEN CHANNELS			
Figure 4.3 Delay difference ≤ 0.13 di PM3382A/84A.	iv in PM3392A/94A or ≤ 0.05 div in		
Settings/procedure PM3392A and PM3	33824		
1 - Apply a fast rise time (≤1 ns) sig	gnal of 0.5V (into 50Ω), frequency 1 MHz,		
to inputs CH1 and CH3. Genera Use a power splitter and two cal 2 - Press the AUTOSET key.	ator in position FAST RISE. bles of equal length to CH1 and CH3.		
3 - Use 50 Ω terminations.			
	nd input coupling to DC. NN TB TIME/DIV to 2.00 ns (PM3392A) or		
to 5.00 ns (PM3382A). 6 - Press the TRIGGER menu key.			
 7 - Select level-pp 'off' and 'dc' trigg 8 - Press the TB MODE menu key. 	ger coupling from the related menu.		
9 - Select 'trig' from the related mer		L L	
11 - Position the rising edges of the	riggered display of the leading edge. signals in the horizontal center of the		
screen, by means of the X POS 12 - Adjust the two traces between the	control. ne dotted lines 0% and 100% by means of		
the CH1 and CH3 POS controls	so that both signals cover each other.	[***]	
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Requirements:

Verify that the delay difference between the two displayed signals is less than 0.5 ns: this equals 0.25 divisions in PM3392A or 0.1 divisions in PM3382A.

Repeat settings/procedure for CH1 and CH4.





- Press the ANALOG key ('DIGITAL MODE' is displayed briefly) and repeat the tests in this chapter for the digital mode. In digital mode, it is not necessary to activate the MAGNIFY function since the timebase ranges up to 2.00 ns/division (PM3392A/3394A) or 5.00 ns/division (PM3382A/3384A).
- Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to analog mode.

4.3.22 Horizontal deflection; display modes and trace separation

The correct working of main timebase (MAIN TB), delayed timebase (DELAYED TIME BASE) and the trace separation is checked.

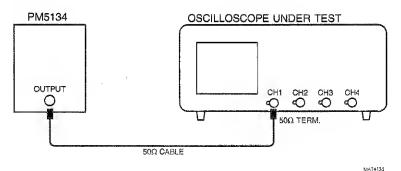
Test equipment;

LF sine wave generator (function generator, PM5134 or PM1538)



Test set-up:

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Settings/procedure and requirements:

- 1 Apply a 2 kHz sine-wave signal of 400 mV(pp into 50Ω) to input CH1.
- 2 Press the AUTOSET key and set CH1 to 0.1V/div.
- 3 Use a 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature.
- 4 Adjust the generator signal to a trace height of 4 divisions.
- 5 Set MAIN TB to 500 μs.
- 6 Press the DTB menu key.
- 7 Set DEL'D TB to 'on' in the DELAYED TIMEBASE menu.
- 8 Set MAIN TB to 'on' in the DELAYED TIMEBASE menu.
- 9 Set the DELAYED TIMEBASE to 50.0 µs.
- 10 Turn the DELAY control (in the DELAYED TIMEBASE section), and verify that the intensified part can be shifted horizontally along the MAIN TB display.
- 11 Operate the TRACK control and check that the DEL'D TB and MAIN TB display can be shifted so that they do not cover each other.

4.3.23 Horizontal deflection; X deflection

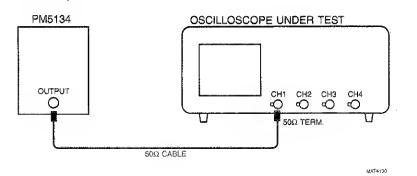
The correct working of the X Y mode (X-DEFL 'on') is tested.

Test equipment:

LF sine wave generator (function generator, PM5134 or PM5138)

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Test set-up:

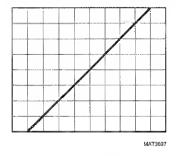


Settings/procedure:

- 1 Apply a 2 kHz sine-wave signal of 800 mV(pp into 50Ω) to input CH1.
- 2 Press the AUTOSET key and set CH1 to 0.1V/div.
- Use a 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature (via VERT MENU key).
- 4 Adjust the generator signal to a trace height of 8 divisions.
- 5 Press the DISPLAY menu key.
- 6 Press the X-DEFL softkey in the DISPLAY menu.
- 7 Select 'on' and 'ch1' as X-SOURCE in the X-DEFL menu.
- Use the CH1 POS and X POS controls to obtain the display shown in the figure below.

Requirements:

Verify that a line with an angle of 45° is displayed.





4 - 30	PERFORMANCE TEST	
4.3.24 Horizontal deflection; MAIN TB de	aflection coefficients	1
		1
The deflection coefficients of the main timebas by means of a calibration signal.	se generator (MAIN TB) are verified	
Test equipment:		
Time marker generator (TG 501)		()
Test set-up:		(
TG 501 OSCILLOSO	OPE UNDER TEST	1
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		[]
	50Ω TERM.	
50Ω CABLE		
	MAT413e	
Settings/procedure:		
1 - Apply a 50.0 ns time marker signal to	input CH1.	
 2 - Press the AUTOSET key. 3 - Use a 50Ω termination. For instrumen 	its with switchable 50 Ω input	
impedance it is recommended to mak VERT MENU key).	e use of this feature (via	
4 - Press the TRIGGER menu key.		[]
6 - Press the TB MODE menu key,		
 7 - Select 'trig' from the TB MODE menu. 8 - Adjust the TRIGGER LEVEL control for 		
 9 - Verify the deflection coefficients of MA MAGNIFY on (*10) according to the r 		1)
deflection error facility of the time mar		
Note:		
- Error limits must be measured between the (there are 11 graticule lines). These are the time of time of the time of time)
- With MAGNIFY on (* 10), the central 10 c		
divisions of MAIN TB are measured.		{····]
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- Only the timebase positions essential for instrument eccuracy are checked.
- Press the ANALOG key ('DIGITAL MODE' is displayed briefly) to perform the tests for the digitel mode. Press the TEXT OFF key for full visibility of the time merker pulses in the central 8 divisions.
- Press the ANALOG key ('ANALOG MODE's displeyed briefly) to return to anelog mode.

MAIN TB setting	Marker p ul <i>s</i> e	Max. error
20.0 ns (PM3392A/94A)	20 ns	1.8%
100 ns	0.1 μs	1.8%
500 ns	0.5 µs	1.8%
1.00 µs	1 µs	1.8%
5.00 μs	5 µs	1.8%
20.0 µs	20 µs	1.8%
500 µs	0.5 ms	1,8%
1.00 ms	1 ms	1.8%
10.0 ms	10 ms	1.8%

Requirements for enalog mode MAGNIFY off (*1):

Requirements for analog mode MAGNIFY on (*10):

MAIN TB setting	Marker pulse	Max. error
2.00 ns (PM3392A/94A)	2 ns	3.3%
5.00 ns	5 ns	3.3%
10.0 ns	10 ns	2.3%
100 ns	0.1 μs	2.3%

Requirements for digital mode:

MAIN TB setting	Marker pulse	Max. error	
2,00 ns (PM3392A/94A)	2 ns	1.8%	
5.00 ns (PM3382A/84A)	5 ns	1.8%	
250 ns	0,5 μ s	1.3%	
500 n <i>s</i>	0.5 µs	1,3%	
20.0 ms	20 ms	1.3%	
1.00 <i>s</i>	1 \$	1.3%	

Check for an undistorted display of the time merker pulses. Timing accuracy should not show a noticeable error. In the MAIN TB setting 250 ns/division, the intervel between successive time merker pulses should be 2 div.'

4.3.25 Horizontal deflection; VARiable mode accuracy MAIN TB.

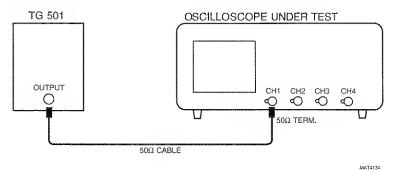
The horizontal MAIN TB deflection coefficients can be varied in steps such as done in 4.3.24. A range of much finer steps can also be selected. Here, the accuracy of this range is checked.

Test equipment:

Time marker generator (TG 501)

Test set-up:

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Settings/procedure:

- 1 Apply a 5 us time marker signal to input CH1.
- 2 Press the AUTOSET key.
- 3 Use a 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature.
- 4 Press the TRIGGER menu key.
- 5 Select level-pp 'off' and trigger coupling 'dc' from the TRIGGER MAIN TB menu.
- 6 Adjust the TRIGGER LEVEL control for a correctly triggered display.
- 7 Set the MAIN TB TIME/DIV to 5.00 us.
- 8 Select the MTB VARiable mode by pressing both MAIN TB TIME/DIV keys at a time: the message; 'VARIABLE TIMEBASE' is displayed briefly.
- 9 Press the 'ns' key and adjust the readout to 2.50 us.

Requirements:

Verify that the horizontal distance between the time markers equals 2 divisions. Use the X POS control to align the marker pulses with the graticule. Now check (across the central 8 divisions) if the timebase accuracy is $\pm 2.8\%$: make use of the deflection error facility of the time marker generator to check this.

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4.3.26 Time cursor accuracy (continuation of 4.3.25)

This test verifies the accuracy of the time cursors.

Settings/procedure:

- Switch the MAIN TB VARiable mode off by pressing both MAIN TB TIME/DIV keys at a time. The message '1-2-5 STEPS'.
- Select 5.00 µs/division for the MAIN TB.
- Switch off the deflection error facility of the time marker generator.
- Press the CURSORS menu key.
- Select 'on' and time cursors (//) from the CURSORS menu.
- Select Δ **T** in the READOUT menu.

Requirements:

- Position one cursor line exactly on the 2nd time marker on the screen and the other cursor on the 10th time marker. The distance between both cursors is now 8 time marker intervals. Check for a cursor readout between 39.5 and 40.5 μs.
- Press the ANALOG key ('DIGITAL MODE' is displayed briefly) and repeat the check in this chapter for the digital mode. Press the TEXT OFF key to have the full screen width available to display the time markers.
- Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to analog mode.

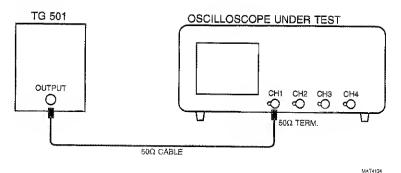
4.3.27 Horizontal deflection; DELAYED TIME BASE deflection coefficients

The deflection coefficients of the delayed timebase generator (DEL'D TB) are verified by means of a calibration signal.

Test equipment:

Time marker generator (TG 501)

Test set-up:



Settings/procedure:

- 1 Apply a 0.5 ms time marker signal to input CH1.
- 2 Press the AUTOSET key,
- 3 Use a 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature (via VERT MENU key).
- 4 Press the TRIGGER menu key.
- 5 Select level-pp 'off' and 'dc' trigger coupling from the TRIGGER MAIN TB menu.
- 6 Press the TB MODE menu key and select 'trig' from the related menu.
- 7 Adjust TRIGGER LEVEL for a correctly triggered display.
- 8 Set the trace height to about 4 divisions.
- 9 Press the DTB menu key and select DEL'D TB 'on' and MAIN TB 'on' from the related menu .
- 10 Set MAIN TB to 1.00 ms and DELAYED TIME BASE to 5.00 $\mu s.$
- 11 Use the DELAY control (in the DELAYED TIMEBASE SECTION to set the time delay to about 0 seconds.
- 12 Adjust the vertical position of the MAIN TB display with the CH1 POS control in the top half of the viewing area.
- 13 Adjust the vertical position of the DELAYED TIMEBASE display with the TRACK control.
- 14 Verify the DELAYED TIMEBASE deflection coefficients with MAGNIFY off (*1) and MAGNIFY on (*10) according to the requirements in the tables. Use the deflection error facility of the time marker generator.

Note:

- Error limits must be meesured between the 2nd and the 10th greticule line (there ere 11 graticule lines). These ere the central 8 divisions.
- With MAGNIFY on (*10), the central 10 divisions of the expanded 100 divisions of DEL'D TB are measured.

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- Only the timebase positions that are essential for instrument accuracy are checked.
- DEL'D TB TIME/DIV is electrically coupled to MAIN TB TIME/DIV; to check the settings in the table press only the MAIN TB TIME/DIV VAR keys.

Requirements for analog mode MAGNIFY off (*1):

DEL'D TB setting	MAIN TB setting	Marker pulse	Max. error
5. 00 μ s	5.00 μs	0.5 ms	1.8%
20.0 µs	20.0 µs	20 µs	1.8%
5.00 µs	5.00 µs	5 µs	1.8%
1.00 µs	1.00 µs	1 µs	1.8%
500 ns	500 ns	0.5 µs	1.8%
100 ns	100 ns	0.1 µs	1.8%
50.0 ns	50.0 ns	50 ns	1.8%
20.0 ns (PM3392A/94A)	20.0 ns	20 ns	1.8%

Requirements for analog mode MAGNIFY on (*10):

DEL'D TB setting	MAIN TB setting	Marker pulse	Max. error
100 ns	100 ns	0.1 μs	2.3%
10.0 ns	10.0 ns	10 ns	2.3%
5.00 ns	5.00 ns	5 ns	3.3%
2.00 ns (PM3392A/94A)	2.00 ns	2 ns	3.3%

4.3.28 Horizontal deflection; delay time multiplier

In this test the minimum and maximum delay time is checked.

Test equipment:

None

Settings/procedure and requirements:

- 1 Press the AUTOSET key.
- 2 Press the DTB menu key and select DEL'D TB 'on' and MAIN TB 'on' from the appropriate menu .
- 3 Set MAIN TB to 500 ns.
- 4 Set DEL'D TB to 50.0 ns.
- 5 Separate the MAIN TB and DEL'D TB traces with the TRACK control.

4 -	36	PERFORMANCE TEST
6		Adjust the delay time to 500.0 ns using of the DELAY control (in the DELAYED TIMEBASE section).
7		Adjust the start of the MAIN TB display exactly on the first graticule line by using the X POS control (at maximum TRACE INTENSITY).
8		Verify thet the difference between the stert of MAIN TB and the start of the intensified pert is between 0.9 to 1.1 divisions.

9 - Adjust the delay time to 5.00 μs with the DELAY control (in the DELAYED TIMEBASE section).

10 - Verify that the difference between the stert of MAIN TB and the start of the intensified part is between 9.9 and 10.1 divisions.

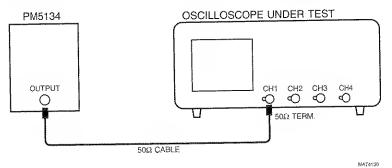
4.3.29 Horizontal deflection; delayed timebase jitter

There is a certain instability in the starting point, the so called jitter, of the DEL'D TB. The maximum allowed jitter is checked in this test.

Test equipment:

LF sine wave generator (function generator PM5134 or PM5138)

Test set-up:



Settings/procedure:

- 1 Apply a 1 MHz sine-wave signel of 120 mV(pp into 50Ω) to input CH1.
- 2 Press the AUTOSET key and set for a trece-height of 6 divisions.
- 3 Use a 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature (vie VERT MENU key).

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- 4 Press the DTB menu key and salect DEL'D TB 'on' and MAIN TB 'on' from tha appropriate menu.
- 5 Set MAIN TB to 500 μs.
- 6 Set DEL'D TB to 500 ns.
- 7 Adjust the dalay tima to 0s using the DELAY control (in tha DELAYED TIMEBASE saction).
- 8 Switch the MAIN TB display to 'off' in the DELAYED TIMEBASE manu, only the DEL'D TB is displayed now.

Requirements:

Verify that the litter of the DEL'D TB is not more than 0.4 divisions (1 part per 25000).

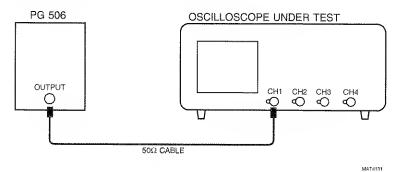
4.3.30 Horizontal deflection; X deflection coefficient via CH1

The amplification of the horizontal amplifier via the vertical input amplifier is checked.

Test equipment:

Square-wave calibration generator (PG 506)

Test set-up:

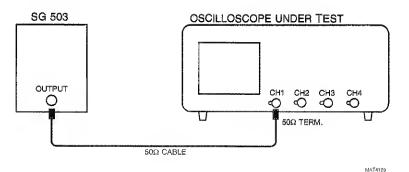


Settings/procedure:

- Apply a 1 kHz square-wava signal of 0.1V to input CH1. Genarator in 'STD AMPL' moda and output not terminated into 50Ω ('LZ' must not appear in lowar part of viewing area).
- 2 Press the AUTOSET kay.
- 3 Sat CH1 to 20 mV and DC coupled input.

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4 - 38 PERFORMANCE TEST	l	
 4 - Press the DISPLAY menu key. 5 - Press X-DEFL softkey. 6 - Select 'on' and 'ch1' from the X-DEFL menu. 		
 Press the CH2 ON key end then the CH1 ON key; the result is that CH2 is on end CH1 is off. 		
Requirements:		
Verify that two dots with a horizontel distance of 4.7 5.3 divisions are displayed.		
4.3.31 Horizontal deflection; X deflection coefficient via 'line'		
The amplification of the horizontal amplifier via the line trigger signal is checked. Do this test only when 220V power is available.		
Test equipment:		
None		
Settings/procedure:		
 Press the AUTOSET key. Press the DISPLAY menu key. Press X-DEFL softkey. Select 'on' and 'line' from the X-DEFL menu. 		
Requirements:		
Verify that a horizontal line of 4.3 to 7.7 divisions is displayed when the line voltage is 220V (rms).		
4.3.32 Horizontal deflection; high frequency response		
In this test, the bandwidth of the horizontal amplifier is checked.	L)	
Test equipment: Constant amplitude sine wave generator (SG 503).		
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Test set-up:



Settings/procedure:

- 1 Apply a 50 kHz sine-wave signal of 30 mV(pp into 50Ω) to input CH1.
- 2 Press the AUTOSET key and set CH1 to 5 mV.
- Use a 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature ('LZ' must be visible in lower part of viewing area).
- 4 Press the DISPLAY menu key and then press the X-DEFL softkey.
- 5 Select 'on' and 'ch1' from the X-DEFL menu.
- 6 Press the CH2 ON key and then the CH1 ON key: the result is that CH2 is on and CH1 off.
- 7 Adjust the input voltage for exactly 6 divisions horizontal deflection.
- 8 Increase the input frequency up to 2 MHz.

Requirements:

Verify that the trace width is at least 4.2 divisions over the complete bandwidth range.

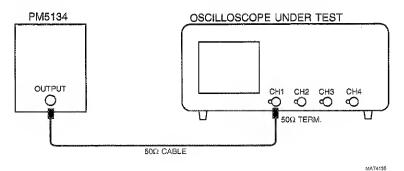
4.3.33 Maximum phase shift between horizontal and vertical deflection

There will be a certain phase shift between the horizontal and vertical amplifier. The value of this shift is measured here.

Test equipment:

LF sine wave generator (function generator, PM 5134 or PM 5138)

Test set-up:



Settings/procedure:

- 1 Apply a 2 kHz sine-wave signal of 1.2 V(pp into 50Ω) to CH1.
- 2 Press the AUTOSET key and set CH1 to 0.2V/div.
- Use a 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature (via VERT MENU key).
- 4 Adjust the generator to a trace height of exactly 6 divisions.
- 5 Press the DISPLAY menu key and then press the X-DEFL softkey.
- 6 Select 'on' and 'ch1' from the X-DEFL menu.
- 7 Increase the input frequency to 100 kHz.

Requirements:

Verify that the phase shift is less than 3° , ≤ 0.32 div, see figure).

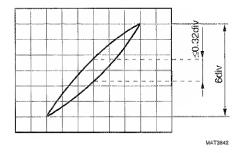


Figure 4.6 Phase shift between horizontel and vertical channel

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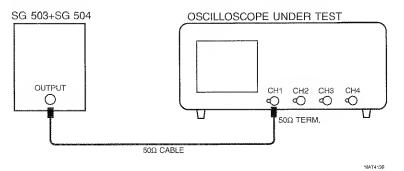
4.3.34 MAIN TB triggering PM3392A/3394A; trigger sensitivity via CH1, CH2, CH3 and CH4

The trigger sensitivity depends on the amplitude and frequency of the trigger signal. In this test the main timebase trigger sensitivity via the CH1, CH2, CH3 and CH4 inputs Is checked.

Test equipment:

Constant amplitude sine wave generators (SG 503 + SG 504)

Test set-up:



Settings/procedure and requirements:

- Apply a 100 MHz sine-wave signal of 1 V(pp into 50Ω) from the SG 503 to input CH1.
- 2 Press the AUTOSET key and set CH1 to 0.5V/div.
- 3 Use a 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature (via VERT MENU key).
- 4 Set the input coupling of CH1 to DC and POSition the signal In the vertical center of screen.
- 5 Select 'trig' from in the menu under the TB MODE mode key.
- 6 Press the TRIGGER menu key and select level-pp 'off' and 'dc' trigger coupling from the TRIGGER MAIN TB menu
- 7 Adjust TRIGGER LEVEL for a correctly triggered display.
- 8 Decrease the amplitude of the input signal.
- 9 Verify that the signal is well-triggered at amplitudes of 0.6 divisions and more.
- 10 Decrease the input frequency to 50 kHz.

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 Verify that the signal stays well-triggered et amplitudes of 0.6 divisions and more. 	
12 - Increase the input frequency to 200 MHz.	
 13 - Increase the input voltage to 1.2 division. 14 - Turn TRIGGER LEVEL. 	have a
15 - Verify thet the signal is well-triggered at emplitudes of 1 division and more.	
16 - Apply a 300 MHz sine-wave signal of 2V (pp into 50Ω) from the SG 504 to input CH1.	
 Adjust the input voltage to 2 divisions. Signal must be in vertical center of screen. 	
18 - Verify that the signal is well-triggered at amplitudes of 2 divisions and	
more; adjust TRIGGER LEVEL when necessary.	
 Repeat the procedure for CH2, CH3 and CH4 for the frequencies 50 kHz (0.6 division input signal) and 300 MHz (2 division input signal) 	
- Press the ANALOG key ('DIGITAL MODE' is displayed briefly), then repeat	P MARK 11
 the tests in this chapter for the digital mode. Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to 	
analog mode.	
4.3.35 MAIN TB triggering PM3382A/3384A; trigger sensitivity via CH1, CH2, CH3 and CH4	
The trigger sensitivity depends on the amplitude and frequency of the trigger signal. In this test the main timebase trigger sensitivity via the CH1, CH2, CH3 and CH4 inputs is checked.	
Test equipment:	
Constant amplitude sine wave generator (SG 503)	
Test set-up:	
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Settings/procedure and requirements:

- 1 Apply a 50 MHz sine-wave signal of 1 V(pp into 50Ω) to input CH1.
- 2 Press the AUTOSET key and set CH1 to 0.5V/div.
- Use a 50Ω termination.
- Set the input coupling of CH1 to DC and POSition the signal in the vertical center of screen.
- 5 Select 'trig' from the menu under the TB MODE menu key.
- 6 Press the TRIGGER menu key and select level-pp 'off' and 'dc' trigger coupling from the TRIGGER MAIN TB menu
- 7 Adjust TRIGGER LEVEL for a correctly triggered display.
- 8 Decrease the amplitude of the input signal.
- Verify that the signal is well-triggered at amplitudes of 0.6 divisions and more.
- 10 Decrease the input frequency to 50 kHz.
- 11 Verify that the signal stays well-triggered at amplitudes of 0.6 divisions and more.
- 12 Increase the input frequency to 100 MHz.
- 13 Increase the input voltage to 1.2 division.
- 14 Turn TRIGGER LEVEL.
- 15 Verify that the signal is well-triggered at amplitudes of 1.2 division and more.
- 16 Increase the input frequency to 200 MHz.
- 17 Adjust the input voltage to 2 divisions. Signal must be in vertical center of screen.
- 18 Verify that the signal is well-triggered at amplitudes of 2 divisions and more; adjust TRIGGER LEVEL when necessary.
- Repeat the procedure for CH2, CH3 and CH4 for the frequencies 50 kHz (0.6 division input signal) and 200 MHz (2 division input signal)
- Press the ANALOG key ('DIGITAL MODE' is displayed briefly) and repeat the tests in this chapter for the digital mode.
- Press the ANALOG key ('ANALOG MODE is displayed briefly for some seconds) to return to analog mode.

4.3.36 MAIN TB/DEL'D TB triggering; trigger sensitivity TVL-TVF

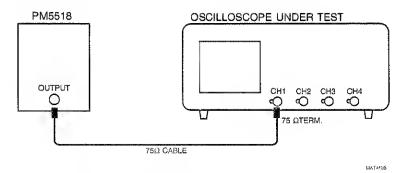
This test checks the trigger sensitivity for television line- and field synchronization pulses.

Test equipment:

TV pattern generator with video output (PM 5518)



Test set-up:



Note: the number a various tests to be performed is numerous. Therefore it is recommended only to check the tv system(s) as used in your country. The number of tests is also limited by the available TV pattern generator.

- Apply a video signal to input CH1 with an amplitude of about 1V synchronization pulse amplitude; use a 75Ω termination instead of internal or external 50Ω.
- 2 Press the AUTOSET key.
- 3 Press menu key TRIGGER and select 'tv' in the related menu.
- 4 Select field 1 or field 2 in the menu.
- 5 Select a line number (e.g. 25) by means of the TRACK control.
- 6 Select pos or neg (depending on the available TV pattern generator).
- Select in the VIDEO SYSTEM submenu hdtv, ntsc, pal or secam (depending on the available TV pattern generator). The maximum number of lines for hdtv can be selected if hdtv is active.

Requirements:

Decrease the amplitude of the input signal and verify that the signal is well-triggered on the tv pulses, at sync pulse amplitudes of 0.7 divisions and more.

4.3.37 DEL'D TB triggering PM3392A/3394A; trigger sensitivity via CH1, CH2, CH3 and CH4

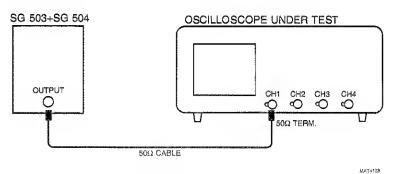
The trigger sensitivity depends on the amplitude and frequency of the trigger signal. In this test the main timebase trigger sensitivity via the CH1, CH2, CH3 and CH4 inputs is checked.

Test equipment:

Constant amplitude sine wave generators (SG 503 + SG 504)

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Test set-up:

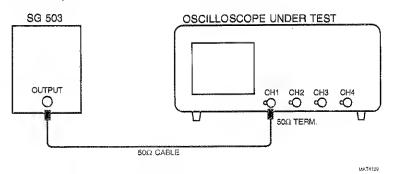


Settings/procedure and requirements:

- 1 Apply a 100 MHz sine-wave signal of 1 V(pp into 50Ω) from the SG 503 to input CH1.
- 2 Press the AUTOSET key and set CH1 to 0.5V/div.
- 3 Use a 50Ω termination. For instruments with switchable 50Ω input impedance it is recommended to make use of this feature (via VERT MENU KEY).
- 4 Set the input coupling of CH1 to DC and POSition the signal in the vertical center of screen.
- 5 Select 'trig' from the menu under the TB MODE menu key.
- 6 Press the TRIGGER menu key and select level-pp 'off' and 'dc' trigger coupling from the TRIGGER MAIN TB menu.
- 7 Adjust TRIGGER LEVEL for a correctly triggered display.
- 8 Press the DTB menu key and select DEL'D TB 'on' and MAIN TB 'on' in the related menu.
- 9 Set MAIN TB to 200 ns/division and DELAYED TIMEBASE to 20.0 ns/division.
- 10 Adjust the DELAY control in the DELAYED TIMEBASE section to a delay time of 1.000 μ s.
- Select 'trig'd' and 'dc' coupling from the DELAYED TIME BASE menu, and press the front panel key TRIG1. Or TRIG2 (if CH2 on), TRIG3 (if CH3 on), TRIG4 (if CH4 on).
- 12 Adjust the DEL'D TB trigger level via the △ control for a well- triggered signal (intensified part must be visible).
- 13 Operate the TRACK control to separate MAIN TB and DEL'D TB for clearly visible displays.
- 14 Decrease the amplitude of the input signal.
- 15 Verify that the DEL'D TB is well triggered at signal amplitudes of 0.6 divisions and more.

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4 - 46 PERFORMAN	CE TEST	
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 Decrease the input frequency to 50 kHz. Set the MAIN TB to 50.0 μs/division and DEL'D TB to 20.0 μs/division. 		
 17 - Verify that the DEL'D TB stays well triggered at signal amplitude 0.6 divisions and more. 	sof	
 18 - Increase the input frequency to 200 MHz. 19 - Increase the input voltage to 1.2 division. 		
20 - Operate the △ control (controls DEL'D TB trigger level).		
 Verify that the DEL'D TB is well triggered at all amplitudes of 1.2 or more. 	divisions	
22 - Apply a 300 MHz sine-wave signal of 2V (pp into 50 ohm) from th generator to input CH1.	e SG504	
23 - Adjust the input voltage to 2 divisions. Signal must be in vertical	center of	
screen. 24 - Verify that the DEL'D TB is well triggered at signal amplitudes of 2		
and more: adjust the ${\scriptscriptstyle\Delta}$ control (DEL'D TB trigger level) if necess	-	
 Repeat the procedure for CH2, CH3 and CH4 for the frequencies 50 (0.6 division input signal) and 300 MHz (2 division input signal)) kHz	9 S
 Press the ANALOG key ('DIGITAL MODE' is displayed briefly) and re tests in this chapter for the digital mode. 	epeat the	· •
- Then press the ANALOG key ('ANALOG MODE' is displayed briefly)	to return	
to analog mode.	1	
4.3.38 DEL'D TB triggering PM3382A/3384A; trigger sensitivity v CH1, CH2, CH3 and CH4	a	
The trigger sensitivity depends on the amplitude and frequency of the t	rigger	•
signal. In this test the main timebase trigger sensitivity via the CH1, CH and CH4 inputs is checked.		
Test equipment:	l	
Constant amplitude sine wave generator (SG 503)	k	
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Test set-up:

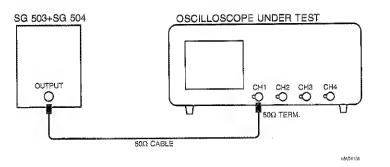


Settings/procedure and requirements:

- Apply a 50 MHz sine-wave signal of 1 V(pp into 50Ω) from the SG 503 to input CH1.
- 2 Press the AUTOSET key and set CH1 to 0.5V/div.
- 3 Use a 50Ω termination.
- Set the input coupling of CH1 to DC and POSition the signal in the vertical center of screen.
- 5 Select 'trig' from the menu under the TB MODE menu key.
- 6 Press the TRIGGER menu key and select level-pp 'off' and 'dc' trigger coupling from the TRIGGER MAIN TB menu
- 7 Adjust TRIGGER LEVEL for a correctly triggered display.
- 8 Press the DTB menu key and select DEL'D TB 'on' and MAIN TB 'on' from the related menu.
- 9 Set the MAIN TB to 200 ns/division and DELAYED TIMEBASE to 50.0 ns/division.
- 10 Adjust the DELAY control in the DELAYED TIMEBASE section to a delay time of 1.000 μ s.
- Select 'trig'd' and 'dc' coupling from the DELAYED TIMEBASE menu and press the front panel key TRIG1. Or TRIG2 (if CH2 on), TRIG3 (if CH3 on), TRIG4 (if CH4 on).
- 12 Adjust the DEL'D TB trigger level via tha △ control for a well- triggerad signal (intensified part must be visible).
- Operate the TRACK control to saparata tha MAIN TB and DEL'D TB for clearly visible displays.
- 14 Decraase tha amplitude of the input signal.
- 15 Varify that the DEL'D TB is wall triggered at signal amplitudas of 0.6 divisions and more.

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4 - 48 PERFORMANCE TEST	1	
16 - Decrease the input frequency to 50 kHz. Set the MAIN TB to		
 50.0 μs/division and DEL'D TB to 20.0 μs/division. 17 - Verify that the DEL'D TB steys well triggered et signal amplitudes of 		
0.6 divisions end more.18 - Increase the input frequency to 100 MHz.		
 19 - Increese the input voltage to 1.2 division. 20 - Operete the ∆ control (controls the DEL'D TB trigger level). 	- 1	
 Verify that the DEL'D TB is well triggered at all amplitudes of 1.2 division or more. 	11	
22 - Increase the input frequency to 200 MHz.		
 Adjust the input voltage to 2 divisions. Verify that the DEL'D TB is well-triggered at signal amplitudes of 	:	
2 divisions and more. Signal must be in vertical center of screen. Adjust the Δ control (DEL'D TB trigger level) if necessary.		
- Repeat the procedure for CH2, CH3 and CH4 for the frequencies 50 kHz	e	
 (0.6 division input signal) and 200 MHz (2 division input signal) Press the ANALOG key ('DIGITAL MODE' is displayed briefly), and repeat the 		
tests in this chapter for the digital mode.		
 Then press the ANALOG key (message ANALOG MODE is displayed briefly) to return to analog mode. 		
4.3.39 Trigger sensitivity in logic mode PM3392A/3394A		
The trigger sensitivity in the logic mode 'pattern' depends on the amplitude and		
frequency of the trigger signal. In this test, the trigger sensitivity is tested with a sine wave via the CH1, CH2, CH3, and CH4 inputs.		
Test equipment:		
Constant amplitude sine wave generator (SG 503)	[]	
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Test setup:



- 1 Press the ANALOG key ('DIGITAL MODE' is displayed briefly) to activate the digital mode.
- 2 Apply a 100 MHz sine-wave signal of 1 V(pp into 50 ohm) from the constant amplitude sine-wave generator to input CH1.
- 3 Press the AUTOSET key, and set CH1 to 0.5V/division.
- 4 Use a 50 ohm termination. For instruments with switchable 50 ohm input impedance it is recommended to make use of this feature (via VERT MENU key).
- 5 Set the input coupling to DC and POSition the signal in the vertical center of the screen.
- 6 Select 5.00 ns/division for MAIN TB.
- 7 Press the TRIGGER menu key and select 'logic', 'pattern', and 'enter' from the related menu.
- Operate the front panel keys TRIG1, TRIG2, TRIG3 and TRIG4 to obtain the trigger pattern Hxxx (x = don't care) in the menu.
- 9 Press the TB MODE menu key and select 'trig' from the related menu.
- 10 Decrease the amplitude of the generator voltage to 1 division.
- 11 Turn the TRIGGER LEVEL control and check that a well-triggered signal is obtained.
- 12 Apply a 300 MHz sine-wave signal of 2 V(pp into 50Ω) from the SG 504 to input CH1.
- 13 Adjust the input voltage to 2 divisions.
- 14 Verify that the signal is well triggered at amplitudes of 2 divisions and more; adjust TRIGGER LEVEL when necessary.
- 15 Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to analog mode.

Repeat the procedure for CH2 with trigger pattern xHxx Repeat the procedure for CH3 with trigger pattern xxHx Repeat the procedure for CH4 with trigger pattern xxxH

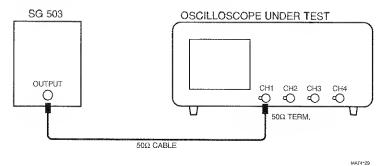
4.3.40 Trigger sensitivity In logic mode PM3382A/3384A

The trigger sensitivity in the logic mode 'pattern' depends on the amplitude and frequency of the trigger signal. In this test, the trigger sensitivity is tested with a sine wave via the CH1, CH2, CH3, and CH4 inputs.

Test equipment:

Constant amplitude sine wave generator (SG 503)

Test setup:



- 1 Press the ANALOG key ('DIGITAL MODE' is displayed briefly) to activate the digital mode.
- 2 Apply a 50 MHz sine-wave signal of 1 V(pp into 50 ohm) from the constant amplitude sine-wave generator to input CH1.
- 3 Press the AUTOSET key, and set CH1 to 0.5V/division.
- 4 Use a 50 ohm termination.
- 5 Set the input coupling to DC and POSition the signal in the vertical center of the screen.
- 6 Select 5.00 ns/division for MAIN TB.
- 7 Press the TRIGGER menu key and select 'logic', 'pattern', and 'enter' from the related menu.
- Operate the front panel keys TRIG1, TRIG2, TRIG3 and TRIG4 to obtain the trigger pattern Hxxx (x = don't care) in the menu.
- 9 Press the TB MODE menu key and select 'trig' from the related menu.
- 10 Decrease the amplitude of the generator voltage to 1 division.
- 11 Turn the TRIGGER LEVEL control and check that a well-triggered signal is obtained.
- 12 Increase the input frequency to 200 MHz.

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4 - 51

- 13 Increase the input voltage to 2 division.
- 14 Turn the TRIGGER LEVEL control, and check that a well-triggered signal is obtained.
- 15 Press the ANALOG key ('ANALOG MODE' is displayed briefly) to return to analog mode.

Repeat the procedure for CH2 with trigger pattern xHxx Repeat the procedure for CH3 with trigger pattern xxHx Repeat the procedure for CH4 with trigger pattern xxxH

4.3.41 Z-MOD sensitivity

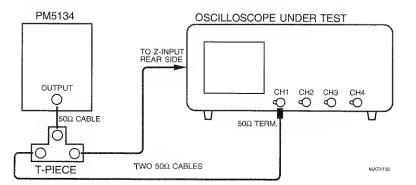
This test checks the sensitivity of the Z modulation facility.

Test equipment:

Square-wave generator (function generator PM 5134 or PM 5138)

T-piece

Test set-up:



Settings/procedure and requirements:

- Apply a 1 kHz square-wave signal, duty cycle 50%, amplitude between 0 to +2.5V (into 50Ω), to input CH1. Use a 50Ω termination directly at the generator output.
- 2 Press the AUTOSET key.
- 3 Set MTB to 0.5 ms/div.
- 4 Set the trace of CH1 in mid position with the CH1 POS control.
- 5 Apply the same signal by means of the T-piece to the Z input (rear side).

	{
4 - 52 PERFORMANCE TEST	
 Adjust TRACE INTENSITY so that only the bottom half of the squarewave is displayed. The top half must be invivisible (0.5 ms light on; 0.5 ms light off). Decrease the input signal to 0.5V. Set CH1 to 0.5V/division. Verify that the top half of the squere wave is visible at full intensity. 	
4.3.42 Probe Adjust signal; frequency end output voltage	[
The Probe Adjust signal is a calibration signal with fixed frequency and voltege. In this test, the values of frequency and voltage are checked.	{
Test equipment:	1
None	[
Test set-up:	r
OSCILLOSCOPE UNDER TEST	hu
Settings/procedure:	
 Connect the Probe Adjust signal to input CH1 and press the AUTOSET key. Select GND of CH1. Set the trace in the center of the screen. Select DC input coupling for CH1. 	([
Requirements:	I
 Verify thet a positive going square-weve signal of 0.6 V(pp) is displayed, i.e. 3 divisions vertical et 0.2V. Verify thet the frequency of the displayed signal is about 2 kHz, i.e. e period time between 4.0 6.0 divisions horizontel at MTB 100 μs/div. 	۱ ۱

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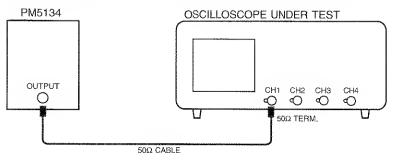
4.3.43 Auto range functions

The AUTO RANGE function of the vertical channels automatically selects the input sensitivity. The result is that the input signal is displayed with 2 to 6.4 divisions amplitude.

The AUTO RANGE function of the main time base (MAIN TB) adjusts the time base automatically so that approximately 2 to 6 waveform periods are displayed.

Test equipment:

LF sine wave generator (function generator, PM5134 or PM5138)



MAT4130

Settings/procedure:

- 1 Apply a 50kHz sine-wave signal of 2 V(pp into 50Ω) to CH1.
- Use a 50Ω termination. For instruments with switcheable 50Ω input impedance it is recommended to make use of this feature (via VERT MENU key).
- 3 Press the AUTOSET key.
- Adjust the generator output voltage to maximum (20 ... 30 V approximately). The signal amplitude now exceeds the 8 div screen height.
- 5 Press the ANALOG key ('DIGITAL MODE' is displayed briefly) to switch the digital mode to on.
- 6 Press the CH1 AUTO RANGE key. Check that the vertical amplitude is automatically adjusted to between 2 and 6.4 divisions.
- 7 Vary the generator output voltage from maximum to 100 mV.

4	- 54 PERFORMANCE TEST		
R	equirements:		
-	Check that the signal amplitude stays between 2 and 6.4 divisions. Repeat this procedure for the other vertical channels that have an AUTO		
S	RANGE key. ettings/procedure:		
1			
2	CH1. - Press the AUTOSET key.	[]	
3 4	 Press the AUTO RANGE key of the main time base MAIN TB. 		
P	equirement:		
	Check that between 2 and 6 waveform periods are displayed.	· ····]	
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5 PREVENTIVE MAINTENANCE

5.1 GENERAL INFORMATION

This instrument normelly requires no maintenance, since none of its components is subject to wear.

However, to ensure reliable and trouble-free operation, the instrument should not be exposed to moisture, heat, corrosive elements or excessive dust.

5.2 REMOVING THE BEZEL AND THE CONTRAST FILTER

The bezel can be removed by pulling the upper rim away from the front panel. This makes the contrast filter accessible for e.g. cleaning. The filter has open spaces at the edges that allow to lift it from the screen with a small screwdriver.

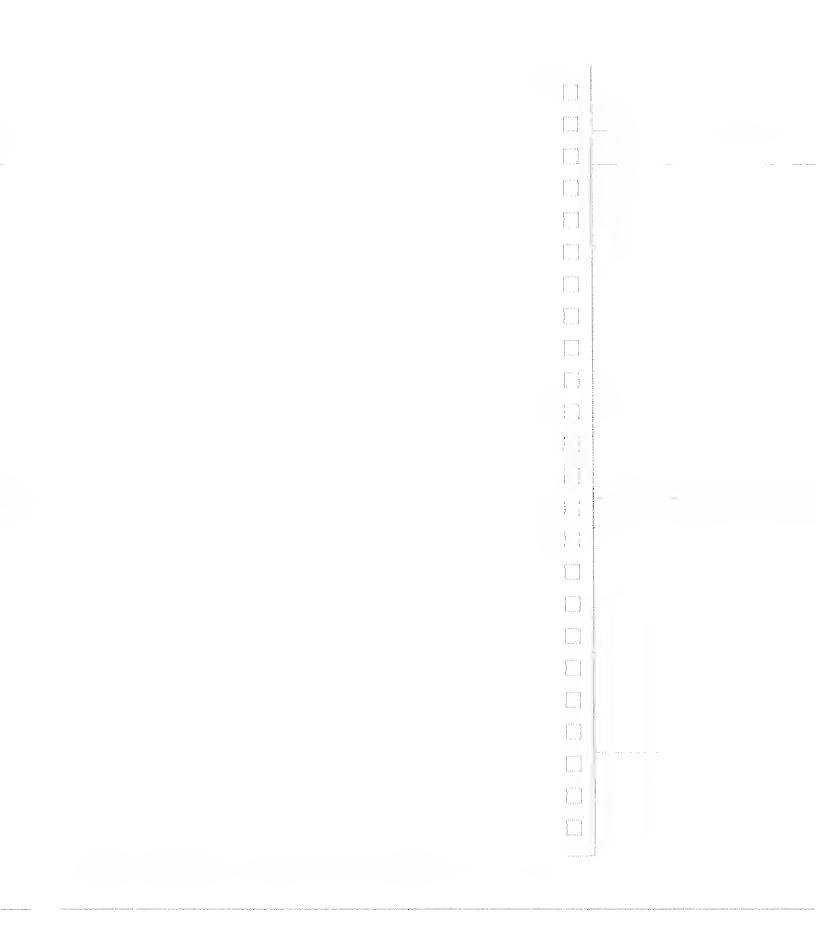
When cleaning the filter, ensure that a soft cloth is used. The cloth must be free from dust and abrasive particles in order to prevent scratches.

When installing the filter take care that the side facing the screen is the one that has a small distance from the screen.

When installing the bezel take care that the grooves for text/softkey alignment are on the right hand side.

5.3 RECALIBRATION

From experience, it is expected that the instrument operates within its specifications for a period of at least 2,000 hours, or for one year if used infrequently. Recalibration must be carried out by gualified personnel only.



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